

## REVIEW

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Cite this: *Nanoscale Horiz.*, 2022, 7, 1427

# Machine learning in electron microscopy for advanced nanocharacterization: current developments, available tools and future outlook

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In the last few years, electron microscopy has experienced a new methodological paradigm aimed to fix the bottlenecks and overcome the challenges of its analytical workflow. Machine learning and artificial intelligence are answering this call providing powerful resources towards automation, exploration, and development. In this review, we evaluate the state-of-the-art of machine learning applied to electron microscopy (and obliquely, to materials and nano-sciences). We start from the traditional imaging techniques to reach the newest higher-dimensionality ones, also covering the recent advances in spectroscopy and tomography. Additionally, the present review provides a practical guide for microscopists, and in general for material scientists, but not necessarily advanced machine learning practitioners, to straightforwardly apply the offered set of tools to their own research. To conclude, we explore the state-of-the-art of other disciplines with a broader experience in applying artificial intelligence methods to their research (e.g., high-energy physics, astronomy, Earth sciences, and even robotics, videogames, or marketing and finances), in order to narrow down the incoming future of electron microscopy, its challenges and outlook.

Received 10th August 2022,  
Accepted 12th September 2022

DOI: 10.1039/d2nh00377e

rsc.li/nanoscale-horizons

## 1. Introduction

Machine Learning (ML) has been a core partner for the scientific and technical breakthroughs of the last decade in multiple

fields, ranging from the less obvious finances to the fundamentals of robotics. It is ubiquitous in a huge variety of scientific fields, providing both tools for automating processes and knowledge-revealing algorithms exploitable without a deep computer science background. Among many others, Electron Microscopy (EM) is a valuable example of how ML is and will be providing a solid framework for the upcoming advances. This review intends to compile and highlight the most important and

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recent advances in Transmission Electron Microscopy (TEM) in which ML has had a key role in the scientific discussion. Additionally, we discuss the future perspectives of ML in EM and how the cross-fertilization with other fields can expand the experimental setups to a yet unexplored domain. From astrophysics, where imaging distant galaxies or searching for black matter generates terabytes per second, to high-energy physics, where the particle colliders can hide particle interactions in a noisy background. From cryo-TEM to the broad window of optical microscopy techniques, to even geological sciences, robotics, epidemiology dynamics or finances. For already many years, these fields have in common that they have fed from machine learning to solve manifold scientific and technical challenges. Therefore, the potential of EM to mirror the progress done in these fields to solve its own future challenges is real, straightforward, and worth a review. This reading is mainly intended for the broad EM and materials science communities, although general microscopy or even data analysis communities may also find useful and mind-broadening approaches to their hurdles. Next section details the progress of ML applied to imaging techniques ranging from traditional parallel-beam TEM or Scanning TEM (STEM) to more recent breakthroughs such as 4D-STEM. TEM spectroscopies and their ML-based applications are discussed in this section as well. After this first part, the section that follows is intended as a pragmatic guide for the community newcomers to provide them with useful (mostly open-source) tools and state-of-the-art computational frameworks developed to apply ML to experimental datasets in a general and less case-dependant basis. Finally, the last part of this review correlates EM with other fields by exploring experiments and data analysis routines that could easily be

transferred from one to another to enrich both tackled ecosystems, therefore revealing an accurate scope of the direction ML applied to EM is going to follow in the next few years.

## 2. Electron microscopy advances with machine learning

### 2.1. Most important imaging developments: from 2D images to 4D-STEM

**2.1.1 Automation of the electron microscope vs. automated data processing.** Given an electron microscopy setup, with no hardware update, there are two main strategies towards acquiring the best possible EM data, which fortunately are not mutually exclusive: data postprocessing, and fine-tuning of the acquisition conditions. On the one hand, data cleaning or denoising is of vital importance to pursue reproducible and statistically meaningful quantitative analysis on STEM data.<sup>1–10</sup> Therefore, using ML, which was already shining in denoising in other scientific and technical fields was the natural decision. Here, the unsupervised approaches were the first approximations that succeeded in this direction. Unsupervised ML has been used to unveil structure and patterns in data and classify them according to complex criteria. Unsupervised approaches were the first to be applied and to succeed thanks to a versatility awarded by requiring no training and only relying on the data to which they are applied.<sup>11–13</sup> Therefore, the first literature pieces applying unsupervised routines to EM data were mainly used to denoise spectral data. The pioneer works of P. Trebbia and N. Bonnet represented the starting point for dealing with Electron Energy Loss Spectroscopy (EELS) with multivariate statistics and currently are a standard first step in any post-processing routine. These ideas flattened the path towards more exotic denoising routines such as unsupervised Gaussian Processing (GP) for cleaner strain mapping.<sup>11,12,14–17</sup>

Nevertheless, just recently more complex supervised methods are emerging and showing their potential to push the current methods forward.<sup>18–20</sup> Generally, supervised ML, specially Deep Learning (DL), aims to mimic human-level operation by finding complex regressions that adapt to the data. Instead, unsupervised ML is the preferred choice when an exploratory approach based on unveiling the internal data structure is needed, although it is still useful for application engineering to provide a more versatile but typically less general performance than supervised solutions. The pros and cons of each approach are more detailed in the next section and extensively throughout the review. In fact, the denoising ideas tackled by unsupervised approaches are being explored from the supervised perspective and beyond. C. Lee *et al.* could increase the Signal-to-Noise Ratio (SNR) in an annular dark-field STEM image of a single-atom defect and measure the strain field around it by training a Fully Convolutional Neural Network (FCNN) on different defect types.<sup>21</sup> Then, the initially hidden-by-noise but theoretically predicted strain field could only be measured after this key postprocessing step. This was because FCNN are primarily designed to find shared patterns in image sets.



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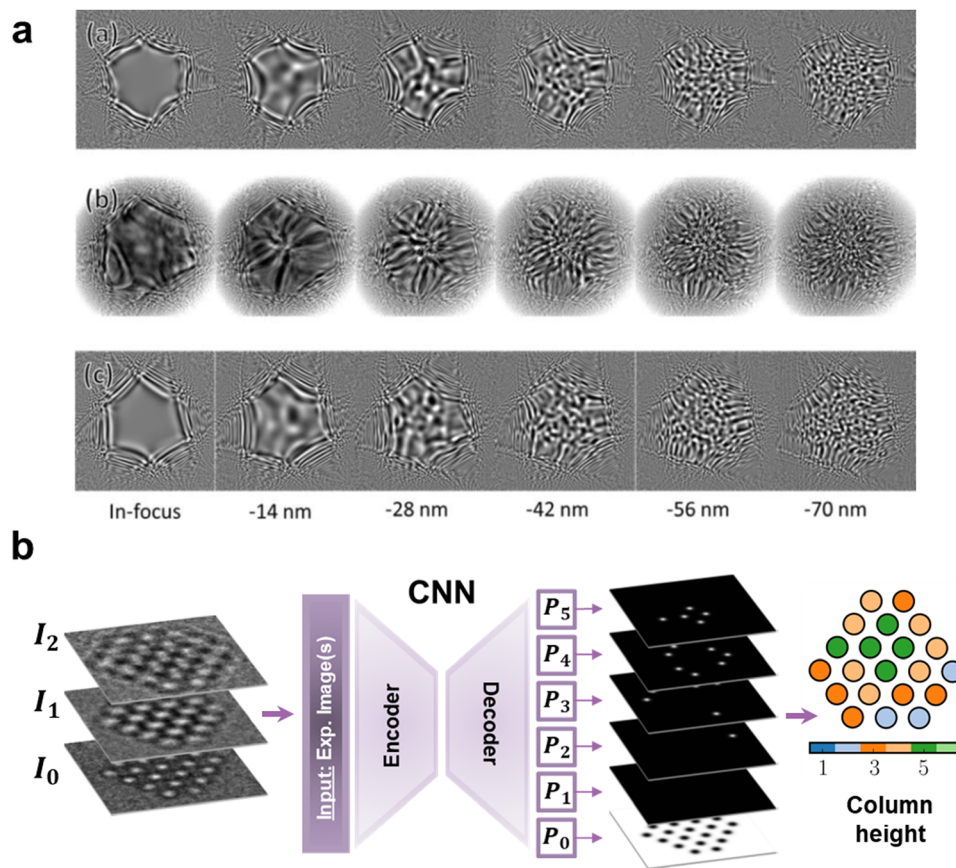
*Supervisor of the Joint Electron Microscopy Center at ALBA Synchrotron (JEMCA) and Founder member of e-DREAM (R. Ciancio, R. E. Dunin-Borkowski, E. Snoeck, M. Kociak, R. Holmestad, J. Verbeeck, A. I. Kirkland, G. Kothleitner and J. Arbiol, e-DREAM: the European Distributed Research Infrastructure for Advanced Electron Microscopy, Microsc. Microanal., 2022, 28, 2900–2902). He is author of 426 scientific publications, with more than 25 700 citations and a h-index of 90 (GoS).*



The successful proofs of concept made additional denoising alternatives arise, including a denoising-noising Generative Adversarial Network (GAN) for the active denoising of STEM data (Fig. 2 GAN)<sup>22–24</sup> or case-independent denoising models that successfully outperformed classical restoration filters for both TEM and STEM.<sup>23,25–31</sup> Interestingly J. Vincent *et al.* studied the latent features learned by the DL model to unveil the nature of the trained denoising dependencies to shine light on what is typically left as a black box. They showed that the FCNN learns to adapt its filtering strategies depending on the structural properties of every particular region in the image.<sup>26–28</sup> Importantly, ML-based noise reduction methods also reached niche EM experimental approaches such as electron holography. This latest example highlights the significance that the ML-based methodology may eventually have in the field and how broad it might be. Electron holography has also benefited from ML-based noise reduction methods. For instance, ML has been used to obtain the accurate phase estimation at low SNR, which flattened the path towards the low-dose holography

analysis of beam-sensitive materials by training a sparse coding model on simulations.<sup>32–34</sup>

On the other hand, computer vision routines for automating the electron microscope alignments have already been reported in order to fine-tune the (S)TEM acquisition process. The first approaches, mainly lead by microscope manufacturers, were based on automating the column (fine) alignments through. For instance, solutions for the automatic aberration correction, or the aberration-free converge angle maximisation are available both through manufacturers and in the literature (Fig. 1a).<sup>35–37</sup> In fact, recent results exploit these provided tools to automate the detection of features of interest in the TEM and their online classification by Few-Shot Learning (FSL).<sup>38</sup> FSL is a sub-area of supervised ML, where new data is classified, despite models are trained with only a few training samples. Meaningfully, K. Roccapriore *et al.* could automate the dynamic STEM exploration and EELS acquisition, through training a deep kernel capable of actively distinguishing physically-significant regions.<sup>39</sup> However, acquisition and alignment automation are not limited



**Fig. 1** The two main trends of Machine Learning (ML) for Electron Microscopy (EM): (a) representing the automation of the microscope tuning and data acquisition, and (b) showing the potential of ML in advanced data analysis. (a) Research work from JEOL devoted to the automatic measurement and correction of aberrations through Ronchigram ML analysis. Each column is linked to a different defocus. The top and bottom rows display simulated Ronchigrams with aberrations determined manually (top) or by a Convolutional Neural Network (CNN) (bottom), while the mid row corresponds to the experimentally equivalent ones.<sup>37</sup> R. Sagawa *et al.*, *Microsc. Microanal.*, 2021, **27**, 814–816, reproduced with permission. (b) Diagram of a CNN trained to count the atoms of an atomic column in gold nanoparticles. The CNN admits both single images and focal series as inputs to classify every atomic column by setting, in the depicted case, a probability ( $P_x$ ) of containing from 1 ( $P_0$ ) to 6 ( $P_5$ ) atoms.<sup>66</sup> Reproduced with permission of J. Madsen *et al.*, *Adv. Theory Simulat.*, 2018, **1**, 1–12 Copyright 2018 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim.





to experiment optimisation, and was key to open unprecedented experimental setups impossible otherwise. In that sense, E. Rotunno *et al.* trained a CNN to align an orbital angular momentum sorter in the context of beam shaping experiments. The authors demonstrated a high accuracy and computational speed in estimating the aberrations induced by the sorter. Such a performance opened the possibility to implement this methodology to every optical system and aberration corrector in the electron microscope for real-time self-alignment.<sup>40–44</sup> Parallely, optical microscopy on, for example, the real-time estimation of the wavefront aberration, and Scanning Probe Microscopies (SPM) on thoroughly autonomous experimental setups, are setting the basis for the automation of more complex microscopy setups.<sup>43–51</sup> These meaningful results, though, constitute nothing but baby steps towards an eventual and highly anticipated fully automated TEM, which is where ML is called to play a pillar role in skyrocketing its advances in the next decade.<sup>52,53</sup> To achieve this, the industry-science cross-fertilisation will be mandatory to open the microscopes up for implementing the research community advances in a user-friendly manner. Moreover, it is our community's duty to validate open and universal data formats to push their support by the companies.<sup>54,55</sup>

However, the current bottleneck of the workflow lies in the analysis of the acquired data, not in the acquisition itself. Therefore, most of the current efforts are pushing towards the automated analysis and ML-based knowledge extraction. For instance, CNNs have widely emerged as excellent tools for the identification, classification, and quantification of defects in EM data. In this way, there is an abundant and successful enough literature to constitute a strong enough basis to conglomerate a starting unitary and general Artificial Intelligence (AI) model that would replace the human intervention in this specific characterisation task. The first studies faced the preliminary complexity of 2D materials in STEM, which allowed the direct correlation between image and structure.<sup>56–58</sup> M. Ziatdinov *et al.* trained an encoder-decoder FCNN to detect the atomic coordinates of Si-doped graphene. Importantly, the trained model proved its ability to adapt to another 2D system,  $\text{Mo}_{1-x}\text{W}_x\text{Se}_2$ , showing a generalised performance. Moreover, the authors converted the outputted atomic coordinates into graphs (*i.e.*, atoms as the graph nodes, with the chemical bonds being the links) for the automated classification of the Si dopants (namely, point defects) based on their bonding with neighbouring Si and C atoms (Fig. 2 CNN).<sup>59,60</sup> This idea has extensively been reproduced in further research in similar 2D systems by taking advantage of the monotonic (with the atomic weight and thickness) dark-field STEM signal.<sup>21,61–64</sup> On the other hand, tackling harder to interpret signal, J. Madsen *et al.* trained a similar FCNN architecture<sup>65</sup> on High-Resolution TEM (HRTEM) simulated micrographs, including focal series and therefore phase information, to identify the atomic coordinates of graphene and count atoms in gold nanoparticles (Fig. 1b).<sup>66</sup> This core idea extended the analysis of HRTEM defects data further to surface contaminants on more complex graphene configurations or to quantitative atom counting in Au nanoparticles.<sup>2,4,66,67</sup>

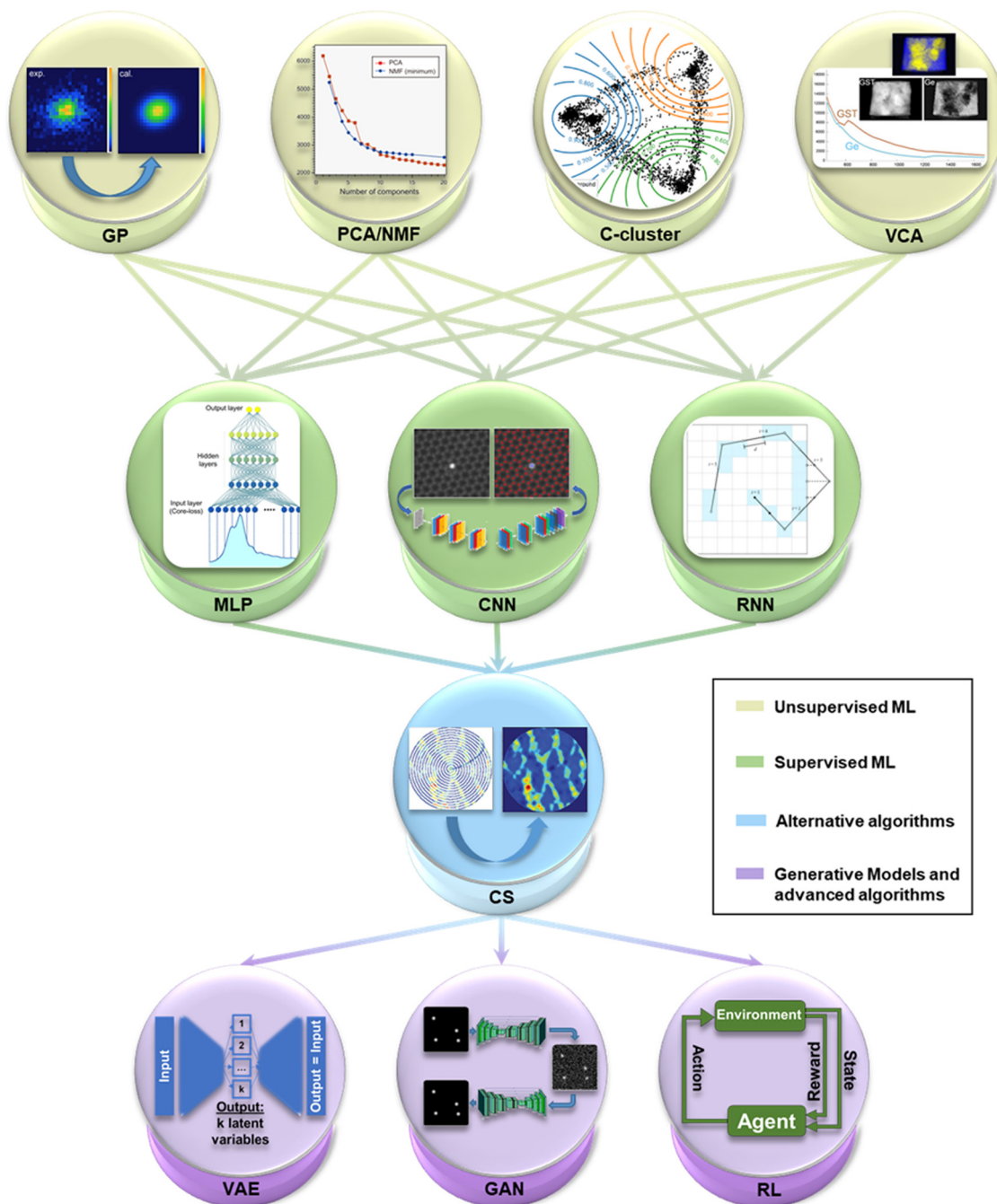
The next step in complexity comprises the defect detection in 3D systems. For this, the available research is sparser and mostly presenting a theoretical scope. The proofs of concept are in relatively simple systems such as zinc blende GaAs, and for seeing its future steps it will certainly be of interest to resemble the progress lastly achieved in SPM with more complex 3D systems, just as expected with the self-driven experiments.<sup>68–70</sup> As a result, we see an outstanding opportunity for pushing the state-of-the-art defect detection to a broader spectrum of 3D systems. To achieve this, CNN combined with unsupervised clustering or anomaly detection methods seem to be the way to go. We envision that this general model will also include the identification of planar defects and dislocations, both in an atomistic nature, and in a more macroscopic or industrially-oriented basis.<sup>71–73</sup>

**2.1.2 Exploratory and knowledge-revealing routines.** ML is excelling in the exploration of local descriptors and knowledge extraction. Most of the available work relies on supervised deep neural networks or in unsupervised complex routines for dimensionality reduction or classification. Nonetheless, we anticipate that the unsupervised generative models will be the key players in pushing the limits of what data science can do for EM. This should drastically reduce the typically time-consuming and tedious generation of training sets, and remove the excessive tailoring and fine-tuning associated with traditional unsupervised methods. This latter idea will be tackled further in Section 4. In fact, it is an expected heritage from other scientific fields that opens new possibilities for materials science and EM.<sup>74</sup> For the sake of simplicity, we divide the following exploratory studies in either unsupervised or supervised approaches.

**2.1.2.1 Unsupervised exploratory routines.** As mentioned earlier, the path of unsupervised ML in EM started with the multivariate analysis of EELS spectra, mainly aimed for noise reduction.<sup>11,12,16</sup> Since the very first nearest neighbour algorithm that aimed to find the shortest path to interconnect data points, unsupervised learning has rapidly grown in popularity in manifold ways and fields. Its strongest virtue is the absence of training process, making its easy access and implementation its key to success. Although the main drawback of unsupervised routines is their lack of robustness when aiming for general models, they can provide an excellent platform for exploring specific imaged systems.

Unsupervised ML on imaging techniques followed the logical path started by the multivariate analysis of spectra. Principal Component Analysis (PCA) constitutes the most straightforward dimensionality reduction and data decomposition available, allowing both data cleaning and classification. Nevertheless, it can also be key in the core of more intricate routines. PCA can map the crystal phases and defects, such as twins or phase boundaries, in encoded dichalcogenide (*i.e.*,  $\text{MoSe}_2$  and  $\text{WS}_2$ ) micrographs with rotational-invariance (*i.e.*, independently of their in-(image) plane rotation).<sup>56,75</sup> The main drawback of PCA is its pure mathematical nature and the inability to directly correlate the obtained results with a physical interpretation.





**Fig. 2** A selection of the key Machine Learning (ML) methods most recurrently employed in Electron Microscopy (EM) imaging and spectroscopy. The first layer contains the first ML techniques that arose in EM, unsupervised methods, consisting of Gaussian Processing<sup>14</sup> (GP), Principal Component Analysis and Non-negative Matrix Factorisation<sup>100</sup> (PCA/NMF) (reprinted from F. Uesugi *et al.*, *Ultramicroscopy*, 2021, **221**, 113168 Copyright 2021 with permission from Elsevier), fuzzy c-clustering<sup>78</sup> (C-cluster), Vertex Component Analysis<sup>101</sup> (VCA) (M. Jacob *et al.*, *Microsc. Microanal.*, 2019, **25**(suppl. 2), 156–157, reproduced with permission), among others. The evolution in complexity leads to the second layer of supervised techniques, with MultiLayer Perceptron<sup>102</sup> (MLP), and Convolutional Neural Networks<sup>59</sup> (CNN) (adapted with permission from M. Ziatdinov *et al.*, *ACS Nano*, 2017, **11**(12), 12742–12752 Copyright 2017 American Chemical Society) and Recurrent NN<sup>103</sup> (RNN). The third layer stands for Compressed Sensing<sup>104</sup> (CS) (reproduced with permission of K. Kelley *et al.*, *Small*, 2020, 2002878 Copyright 2020 Wiley-VCH GmbH), a group of alternative algorithms with powerful compatibility with ML. Finally, the last layer outputs the future of ML in EM in the use of generative models like Variational AutoEncoders (VAE) and Generative Adversarial Networks<sup>22</sup> (GAN), and more complex learning paradigms such as Reinforcement Learning (RL).

This is why alternative physically-constrained methods arose. For instance, ensuring every component is thoroughly positive in its domain with Non-negative Matrix Factorisation (NMF).

For instance, R. Kannan *et al.* tested NMF in spectral data generated by multimodal STEM and X-ray Diffraction (XRD).<sup>58</sup> The authors generated a hyperspectral dataset from the sliding



window Fast Fourier Transform (FFT) of a single atomically resolved STEM image. Then, they mapped the crystallographic phase by assigning a phase to each meaningful NMF component extending the previous PCA approach further.<sup>58,73,76,77</sup> Similarly, B. Martineau *et al.* also applied NMF, combining it with fuzzy c-means clustering (*i.e.*, assigning each datum a probability of being in each cluster), to overcome the effects of sample bending on the diffraction patterns obtained in precession mode while scanning twinned GaAs nanowires (Fig. 2 C-cluster).<sup>78</sup>

The outstanding balance between the ease of implementation and the remarkable results obtained by PCA or NMF raised the interest to explore higher-complexity unsupervised routines.<sup>63,79–81</sup> Variational AutoEncoders (VAEs) are emerging as a powerful dimensionality reduction tool able to extract physically meaningful information (Fig. 2 VAE). Although they are catalogued as unsupervised processes, they require the manual specification of the features of interest of the data for that study. For example, in a crystal phase classifier, the mapping of the phases throughout the micrograph should be manually given *a priori* as input. Then, by specifying the features of interest in the micrographs, the data is compressed and decompressed in an encoder–decoder architecture that generates a few latent variables that “simply” explain the variability of the original image.<sup>82–84</sup> These compressed latent variables can further go through complementary clustering or refinement routines to eventually be correlated with physically meaningful features, such as local crystallography, defects, or subtler sample-dependent identifiers.<sup>85–87</sup> Relevantly, S. Kalinin *et al.* used rotationally invariant VAEs (rVAEs) to explore the evolution of Si on graphene under the electron beam. To achieve so, the authors encoded the variability of this model system in just three latent variables: rotations, and *x* and *y* translations. The latest proved the robustness of VAEs to track time-resolved data, outperforming traditional unmixing methods by capturing the rotation information in just a single latent variable and clarifying the origin of the remaining variability in other independent variables.<sup>88</sup> As indicated by their name, rVAEs are phenomenal tools to evaluate features that are susceptible to suffer in-plane rotations, which may be particularly advantageous for ferroelectric, ferromagnetic or generally polar materials. In that sense, S. Kalinin *et al.* applied rVAEs to correlate the rotation latent variable with the orientation of ferroic variants, directly locating the unit cell deformations through the sample, independently of the structural and chemical variability and under non-ideal imaging conditions.<sup>89</sup>

**2.1.2.2 Supervised exploratory routines.** Mimicking the intricate neural structure of the human brain, and even building new neuromorphic hardware architectures, is the latest revolutionary idea in computer science, together with quantum computing, to overcome the computing capabilities of classical algorithmics. Since the very first perceptron proposed by W. Pitts and W. McCulloch, to the explosion of DL, neural networks and other supervised algorithms have systematically outperformed classical classification and regression tasks.<sup>90,91</sup>

Supervised routines, and paradigmatically DL, are based on a training process that requires the preparation of a large

dataset representing the statistical variability of the problem data. The key idea is that after engineering a model (*i.e.* the neural network) capable of recognising the statistical variability and descriptors of the data (*i.e.* training process), any data lying within these statistical limits could be automatically and robustly analysed. Thus, in the same way a linear regression would adapt to data following a linear trend, neural networks generate complex non-linear multi-dimensional regressions that can adapt, in theory, to any data structure. However, the main drawback relies on the resource-consuming model set-up, which essentially consists of generating and getting the training data ready, and tailoring the model architecture to the problem. Nevertheless, recent results elucidated that the automatic AI-based architecture and hyperparameter fine-tuning (*i.e.* the supervised model properties) is currently possible for EM problems and datasets.<sup>92–95</sup>

Currently, the main trend of DL in the field has been the finding of atomic positions and their correlation with mathematical graphs, as stated before, for defect identification<sup>59–61,66,67,70</sup> and quantification,<sup>96</sup> or image denoising.<sup>21,26–28</sup> Nevertheless, the extraction of further properties with physical meaning can be envisioned from this idea, such as atom counting or quantitative TEM in a broader sense.<sup>3,4,66</sup> Interestingly, the atomic positions identification started with FCNN on 2D systems and model 3D systems. However, FCNN extended their reach to higher complexity systems, therefore exhibiting their generalisation capabilities. For example, M. Ziatdinov *et al.* trained a FCNN to detect the atomic positions of a La-doped BiFeO<sub>3</sub> system to extract local descriptors of the lattice such as the polarisation.<sup>97</sup> Importantly, local descriptors coming from supervised networks can be post-processed by unsupervised means to group them in physically equivalent categories. Indeed, the authors compressed the supervised output with PCA and grouped it by *k*-means clustering. As a result, they could map back the distribution of the lattice distortions in the original image.<sup>97,98</sup> Multimodal approaches, as the former example, mostly introduced in atomic column finding and phase mapping, are of huge importance nowadays to go through the intrinsic limitations of standalone models. These methodologies are common for dealing with data outputted from neural networks, as their formats are susceptible to being further simplified by classical unsupervised routines or by more complex algorithms such as VAEs.<sup>85,89,99</sup> In fact, most of the DL-based studies available in the literature for atomic column-positioning routines interact with similar data (roughly, atomic columns “always” appear as rounded dots in micrographs). Thus, the first step towards a universal model could be a shared transfer learning-based starting point, which would save time and resources in updating and tailoring it for any specific or individual need. And for that, the attention paid to these multimodal approaches would perfectly fit in the intercommunication of the specific models towards a more general and beneficial model.

The next complexity stage for supervised algorithms was shifting to the reciprocal space analysis. Fortunately, ML methods are sensitive to geometry to easily detect symmetry constraints.



This makes them excellent options for dealing with crystals and their reciprocal space description. In order to simplify the electron diffraction data and reduce the computational pressure, the 2D diffractograms can be turned into 1D spectra. In that sense, as J. Aguiar *et al.* proposed, a CNN can be trained on electron diffraction data or equivalently, FFTs obtained on atomic resolution STEM micrographs, to identify the space group of a given unit cell.<sup>105</sup> The key idea relies on the azimuthal integration of diffraction patterns (or FFTs) to generate a line profile containing the whole information in a simplified encoding. The authors used a huge dataset with 571.340 crystals to reach a classification confidence of 95% in regular SNR scenarios, and of the 70% in noisier data. Similarly, and by directly tackling 2D diffraction data, R. Vasudevan *et al.* worked on a CNN capable of determining the Bravais lattice of both experimental and simulated Scanning Tunnelling Microscopy (STM) and STEM images. Indeed, the authors mapped this Bravais symmetry distribution within a time-resolved set of images of electron beam-damaged WS<sub>2</sub>.<sup>61,106,107</sup> Interestingly, these constitute preliminary signs highlighting the interest to apply supervised methods, and generally ML, to evolving systems or *in situ* setups. This idea is reviewed in detail a few paragraphs below.

The high versatility of supervised methods confirmed their ease to handle manifold experimental data productively. Nonetheless, the ML practitioners in the community attempted the ML implementation in microscopy simulations, too. Simulations are key in EM to facilitate the interpretation of micrographs taken under complex conditions, and also allow for virtual experiments on the characterised structures. In this direction, R. Pennington *et al.* combined Density Functional Theory (DFT) calculations and a neural network-based optimisation algorithm both to improve TEM simulations and to retrieve properties along the beam propagation dimension (properties like ferroelectric polarisation domains and strain). In this latter case, this methodology was tested with simulated Convergent-Beam Electron Diffraction (CBED) patterns, although it should be comparable to the available imaging and spectroscopic modes.<sup>103,108</sup> Indeed, literature extensively showed that features learnt by DL may extrapolate to data which *a priori* had no relation with the training data. Interestingly, the way DL models learn these complex routines is still mostly unknown to date in a general basis. The generated weights of the networks are task-specific, which hampers distilling general and common patterns. J. Horwath *et al.* carefully checked the learned convolutional filters of a U-Net architecture intended to segment TEM images of rounded gold nanoparticles.<sup>109</sup> They learnt that the kernels filters could be easily engineered by combinations of traditional filters (*i.e.*, Laplacian, Gaussian, *etc.*), emphasising the importance of tailoring the model architecture for a task.<sup>26,109–112</sup> At this point, it is important not only to clarify the nature of DL applied to (materials) science, from a computer science perspective, but also to extract individual filters repeatedly observed in networks sharing objectives and apply them to simplify specific data treatment problems.

As reviewed, in EM the typical research workflow involving supervised ML consists of tackling a specific problem and

generating a supervised model that fits into the target information. However, the solutions to these tailored research problems are meant to converge into broader unified models with a customisable or modular nature gathering all the developed features at once. In fact, the latest EM hardware evolutions and their software assistance were meaningfully based on automation. It was fundamental for cryo-TEM and its autonomous particle search and analysis, and also played a role in delivering intuitive parallelisation capabilities to the newest microscopes and focused ion beam machines. Therefore, it is important to emphasise the effort led by the computational EM community towards the open software and its easy accessibility and centralisation. This idea should make the next incoming hardware and software evolution of EM and materials science be deeply based on ML. Initiatives such as sharing public codes, libraries and repositories, or “papers with code” (*i.e.*, Jupyter notebooks, Google Colab notebooks) to straightforwardly reproduce the data analysis shown in the publications, foresee a new format for the papers that journals will need to embrace from now.<sup>89,97,105</sup> Interestingly, these paradigmatic tendencies confirm that this new incoming evolution is already here.

**2.1.3 Processing of high dimensionality data by machine learning.** In the following, we evaluate how ML is inducing welcomed changes in the way in which higher dimensionality EM data is processed. The new generation of pixelated detectors is powering the acquisition of large data volumes, already close to the domains of big data. As a result, data handling strategies relative to that field, such as processing the data in fragments or chunks, need to be incorporated for the EM community. Numerous techniques that fit into the high dimensionality data tag, like Lorentz microscopy or Differential Phase Contrast (DPC) STEM, have benefited from ML to improve the retrieval of the phase information.<sup>113</sup> Nevertheless, in the next paragraphs we will mainly focus on the management of huge data streams generated by ptychography and 4D-STEM nanodiffraction.

Ptychography is a promising technique based on the mathematical reconstruction of the electron phase information (*i.e.* the inverse problem) based on the acquired experimental signal. It has recently proven its high value achieving the current spatial resolution record in EM, 16 pm, only limited by lattice vibrations.<sup>114–118</sup> Whilst it is still an early technique, the community has identified the need to enhance the computations assisting the reconstructions. For that, ML applied to ptychography is currently relying on optimising the phase retrieval routines.<sup>119</sup> For instance, M. Schloz *et al.* combined the multislice formalism (interestingly, implemented with a multilayer perceptron, which is a fully-connected neural network) with gradient descent regularised optimisation to perform the reconstruction. The multislice formalism accounting for multiple scattering improved the resolution, and the regularisation allowed to diminish the oversampling requirements and still reconstruct the experimental data under noisy conditions.<sup>120</sup>

After improving the reconstruction mechanisms and relaxing its constraints, the ML practitioner's aim is to make ptychography an end-to-end process. In this way, M. Cherukara *et al.* trained a FCNN (named PtychoNN) to retrieve both the

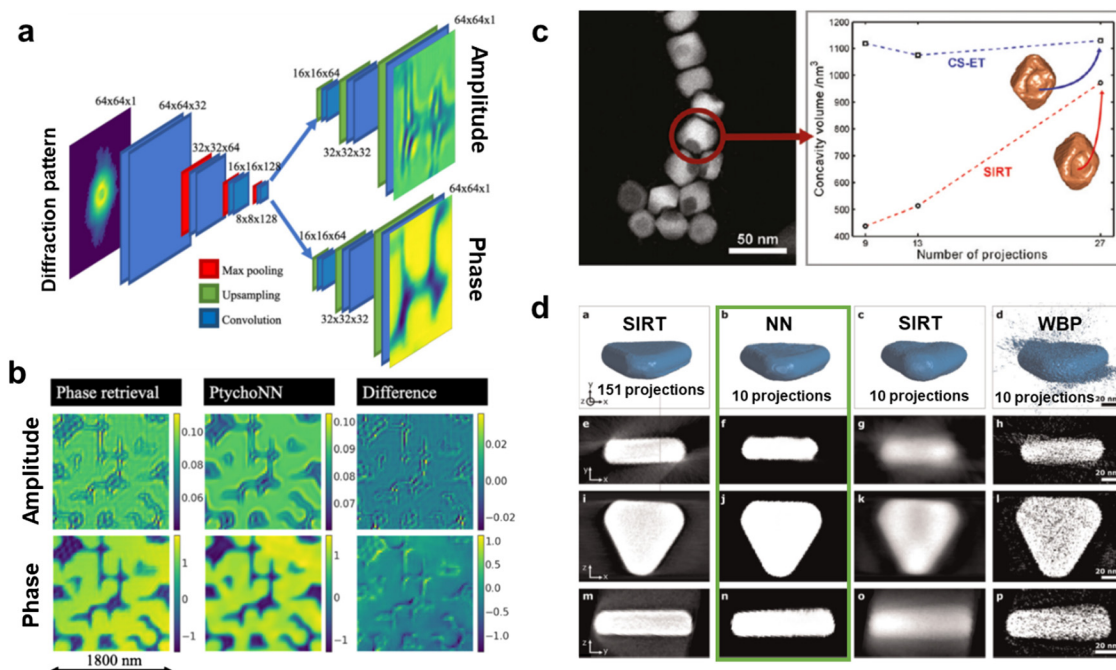




amplitude and phase from diffraction data. The authors claimed to achieve a fast, sub-sampling tolerant and computationally-friendly method to solve the inverse problem in real time, in a single step (Fig. 3a and b).<sup>121</sup> The computational speed of the FCNN opened real-time ptychography, which could be potentially used to apply ptychography in dose-sensitive and thick samples. Consequently, ML pushed even more the relaxation of the required electron dose with advanced methods. DL, specifically deep Reinforcement Learning (RL), was used for this purpose. RL learns by rewarding the behaviours or patterns we are interested in, while penalising the rest. For that, RL was studied to generate real-time adaptive scanning paths that benefited the relaxation of the overdetermination constraints towards low dose experiments (Fig. 2 RL). For that, a Recurrent Neural Network (RNN) rewarded the most physically meaningful diffraction patterns (*i.e.*, highest phase dynamic range) and automatically engineered the most optimal scanning path for the reconstruction.<sup>122,123</sup> This example of ptychography expanding its target materials to beam-sensitive and thick devices is a paradigmatic victory of ML. It accentuates that even in refined techniques capable of leading to super resolution, ML can still play a role improving the classical approach. Nevertheless, the acquisition of diffraction patterns to generate a 4D dataset is

more general and goes beyond ptychography. Nanobeam diffraction patterns of very wide fields of view can be obtained by means of 4D-STEM nanodiffraction (generally just 4D-STEM for simplicity). In order to collect the 4D-STEM 2D diffraction patterns, pixelated detectors are a cornerstone that also received the attention of ML practitioners.<sup>124–128</sup> In fact, so far, we have reviewed how close the ML software development can be with the progress of the actual hardware receiving the signals. Despite that, it is not common in the bibliography to directly face the hardware, or as in the following case, the capabilities of the before mentioned detectors. Interestingly enough, G. Correa and D. Muller exceptionally pushed the performance of these detectors by training a CNN on Monte Carlo electron beam trajectories. The idea was the prediction of experimental beam paths and detector hitting spots to achieve sub-pixel super-resolution.<sup>129</sup> Again, similar research is currently scarce in the literature, but certainly illustrates what we were referring to as the next coupled software–hardware evolution in EM.

It is currently much more common to find ML on 4D-STEM focusing on facilitating the extraction of physical properties of huge datasets. To do so, traditional algorithms would inevitably take ages. A common approach, as happens with regular atomically-resolved (S)TEM data, is to employ unsupervised



**Fig. 3** Machine Learning (ML) applied to Electron Microscopy (EM) high-dimensionality data analysis. (a) An encoder–decoder convolutional neural network dubbed PtychoNN designed for the ptychography reconstruction of the amplitude and phase information out of single diffraction patterns. PtychoNN allowed (b) to reconstruct the wave information with higher fidelity than traditional iterative phase retrieval algorithms, and up to 300 times faster.<sup>121</sup> Reprinted from M. J. Cherukara *et al.*, *Appl. Phys. Lett.*, 2020, **117**, with the permission of AIP Publishing. (c) Comparison of the accuracy of the Electron Tomography (ET) reconstruction of an iron oxide nanoparticle with a concavity between the SIRT algorithm and a compressed sensing (CS)-based one. The CS algorithm reproducibly estimated the concavity size independently of the number of acquired projections while the SIRT approximation was strongly affected by that.<sup>148</sup> Reprinted with permission from Z. Saggi *et al.*, *Nano Lett.*, 2011, **11**, 4666–4673. Copyright 2011 American Chemical Society. (d) ET reconstruction by, from left to right, the SIRT algorithm with 151 acquired projections, and a Neural Network (NN), SIRT and WBP algorithms with 10 projections, and their orthoslices in the three bottom rows. The NN overwhelmingly improved the 10 projections SIRT and WBP reconstruction, but also the reference 151-projections SIRT. The NN orthoslices clarified its superior performance highlighting the potential for low-dose ET.<sup>154</sup> Reprinted from E. Bladt *et al.*, *Ultramicroscopy*, 2015, **158**, 81–88, Copyright (2015), with permission from Elsevier.





methods to give a physical origin to a mathematical component, such as assigning each NMF/PCA component a characteristic diffraction pattern. Its recent success unveils unsupervised techniques as a standard for the processing of high-dimensional datasets, resembling the multimodal crystal phase mapping we described for regular STEM.<sup>130–135</sup> Indeed, the mapping of crystal phases and their relative rotations was tested with success in complex oxide systems (e.g.,  $\text{Ti}_{0.87}\text{O}_2$  vs.  $\text{Ti}_2\text{O}_3$ ) and in dichalcogenide multilayers, such as  $\text{MoS}_2$  bilayers.<sup>100,136</sup>

Supervised ML has also been proven beneficial for 4D-STEM, as regarded in ptychography. Nonetheless, its mere consideration can become thoroughly more time-consuming than in regular (S)TEM, given the higher dimensionality of the former and the consequent higher-complexity network-architectures required.<sup>137</sup> Explicitly, the high dimensionality engineering of training data would nowadays become the main implementation barrier. Therefore, unsupervised methods would constitute the best starting point for newcomers diving into the smart processing of 4D datasets. Nevertheless, the preparation of useful 4D training sets is still possible as showed by the 3D-CNN trained on simulated diffraction patterns arising from a  $\text{LaAlO}_3$ - $\text{SrTiO}_3$  heterostructure.<sup>138</sup> In this case, the capability of the resulting model was to distil whether the interface presented atomically sharp steps or a chemically diffuse nature, a task often complicated even for trained microscopists. The necessary tools for reproducing this and the previous cases, as well as to deploy custom models on 4D data are described in detail in Section 3.

**2.1.4 Compressed sensing and machine learning for tomography and *in situ*.** In the previous paragraphs we have pointed out that general statistical parameter estimation and DL methods allowed for atom counting and local structure determination.<sup>3,4,9,29,66,139,140</sup> These methods may result in an eventual 3D model representative of the initially unknown nanostructure. Even though these tools can become powerful enough to solve certain case studies, the reproducible extraction of reliable 3D information compulsorily demands Electron Tomography (ET). In order to relax the time-consuming and high-dose experimental setups that this technique usually demands, Compressive Sensing (CS) has recently become a keystone for the recent results in the field.<sup>141,142</sup> In just a few words, CS allows to reconstruct a randomly-sampled sparse signal beyond the Nyquist limit by means of a mathematical algorithm that contemplates the sampling path. Although strictly speaking CS does not fit inside the ML tag, its shared objective and similar methodology make it worthwhile being considered in this review.

As mentioned earlier, the research on CS applied to tomography mostly tries to improve the current tomogram reconstruction schemes. Virtually every experimental setup would benefit from having its total dose reduced. For that, CS pointed towards a dose-reduced but also real-time and shape-independent tomography.<sup>143–147</sup> This idea provided extra sensitivity to morphological features difficult to resolve, such as surface rugosity and porosity, also allowing the tomography of challenging shapes. For example, Z. Saghi *et al.* could both quantitatively evaluate the concavities of iron oxide nanoparticles and to

reconstruct additional challenging biological needle-shaped tomograms by means of CS (Fig. 3c).<sup>146,148</sup> Besides, the promising achievements of CS in the field opened the tendency of ML to emulate these algorithms and make their implementation more agile. This played a substantial role after involving DL in the equation.<sup>149–153</sup> For instance, E. Bladt *et al.* went beyond CS with the implementation of a multilayer perceptron capable of automatically reconstructing the sample upon a sparse tilt series, without the user-defined prior knowledge of the sample typically required in traditional reconstruction algorithms (Fig. 3d).<sup>154–156</sup> Interestingly, as it happens with ML mimicking DFT and multislice, ML copying CS enforces the future of ML overwriting classical algorithms and making them worth a try when contemplating a scientific problem.

Beyond tomography, CS burst in with the development of non-rectangular scanning paths in STEM, which promise faster and lower dose STEM experiments.<sup>157,158</sup> The idea lies in the measurement of (random) sparse pixels and the mathematical inference of the unsampled signal. This approach was successful for practical scenarios such as undersampled lattice distortions like point defects, in both STEM imaging and EELS.<sup>159</sup> However, as indicated, the velocity boost is not the main attraction. Its application for beam-sensitive nanostructures as a way to ensure not surpassing the maximum allowed dose was also corroborated experimentally. X. Li *et al.* could perform real-time CS-based reconstructions on beam-sensitive materials (*i.e.*, graphene) with nonrectangular spiral and Lissajous scans.<sup>160</sup> Interestingly, the scanning path optimisations were parallelly extended in SPM following this same logic.<sup>104,160,161</sup> It is not surprising, then, that as happened with CS-tomography, DL also emulated the goodness of CS in STEM path optimisation. For that, J. Ede and R. Beanland modelled a GAN to automatically reconstruct nonrectangular scan paths. Based on this, J. Ede additionally created a sample-aware adaptive scan path learned by reinforcing a RNN that scores the reconstruction of the GAN from the previous study (Fig. 2 RNN).<sup>162,163</sup> This research piece constitutes one of the most sophisticated examples of ML applied to EM currently available. Nonetheless, it unveils that the expertise in a wide ML toolset is key for bringing the applications into a next level. Indeed, it is the shown stacking of complementary ML tools (referred previously as multimodal ML) what would lead to general ML models for EM. In favour of this, in Section 3 we review the currently available ML toolset for easily transferring this knowledge into helpful algorithms, in a practical and easy-going way.

CS has also showed potential for compressing the data volume associated to time series in *in situ* experiments.<sup>164</sup> As introduced before, this shines light on the important role ML can play when dealing with *in situ* experimental setups, topic that will conclude this first section of the review.<sup>165–168</sup> In the previous paragraphs we have already reviewed some examples in which the effect of the beam, mainly on 2D materials, was carefully considered. Specifically, the potential reproducer of these experiments would find value in the evaluation of changing defects or phase distributions.<sup>26,29,61,88,109</sup> For instance, T. Patra *et al.* studied  $\text{MoS}_2$  in different time scales



by combining ML-enhanced dynamic simulations of defects with time-resolved HRTEM. They found that the long-time scale displacement of the defects could lead to rapid (up to picoseconds) 2H to 1T phase transitions.<sup>62</sup> Remarkably, ML unlocked the required time resolution to capture this ultrafast phase transitions invisible to classical *in situ* data analysis.

The current investigations involving ML on *in situ* experiments are only on preliminary stages, fundamentally facing relatively simple systems such as nanoparticles, and their evolution in size and morphology. For these primary applications, the methodology to deploy is not advanced either, which makes it even more accessible to newcomer ML practitioners. Some of these works rely on combining traditional computer vision routines (*i.e.*, thresholding and edge detection) with unsupervised clustering to draw the contours and central positions of the particles.<sup>169,170</sup> In this context, the clustering could be understood as a sample-aware thresholding that better adapts to the changing conditions of time series or dynamic stimuli. In that sense, Y. Qian *et al.* developed an unsupervised segmentation routine that is representative of what can be obtained by taking advantage of relatively simple clustering routines. The authors pooled the *k*-means clustering (intensity evaluation) with the edge detection (gradient evaluation) to extract complete statistics from videos of silica nanoparticles.<sup>171,172</sup> Interestingly, the authors achieved a robust method that was tested on more complex situations such as the environmental TEM study of the formation of Fe nanoparticles after the dewetting of a Fe thin film.<sup>173</sup>

The previous example remarked that evolving systems may find in simple algorithms the best ally to capture their dynamics without the need to deploy complex codes. However, abrupt intensity changes in the micrographs coming from, for instance, thickness variations, or compositional changes can make unsupervised routines miss. If this case is identified, it would probably require a supervised approach specifically trained for these observed image variations. This may allow to push the conditions of the tolerated *in situ* experiments and still get robustness, at the cost model-design resources. For example, supervised routines based on the CNN U-Net architecture successfully segmented and tracked the statistics of nanoparticles. As U-Net was the first notorious DL model for dealing with scientific images (*i.e.* segmentation of cells), most of the currently available CNN for microscopy are fine tunings of U-Net.<sup>65</sup> Then, before the time-consuming neural network architecture design, it is always worth to try first with U-Net as a reliable supervised proof of concept. In fact, meaningful results were obtained just with U-Net both in liquid and gas phases, and under temperature changes, surpassing the former traditional and unsupervised approaches.<sup>174–176</sup> In any case, it is clear that ML has much more to say in *in situ* EM, and it will surely explode as soon as the *in situ* machinery becomes a much wider standard within the community. For instance, we envision the use of CS to reduce the required frame rate, similarly to CS-tomography, further allowing the chemical and physical tracking of beam-sensitive materials. Furthermore, we envisage the use of VAEs to encode time-dependent meaningful descriptors for its direct correlation with actual materials dynamics.

At the same time, the computing efficiency of ML and the advent of fast detectors could open the real-time correlation of *in situ* experiments with parallel simulations that automatically record and explain the evolution of materials in a limitless scenario of knowledge extraction.

As a final comment for this first section devoted to imaging, we cannot forget about those technical fields in which ML has extensively helped to push the limits of the achievable. In fact, as this review is mainly intended for the materials science community, we have not covered ML on cryo-TEM, in which the problems solved are mainly bio-related. However, it is important to keep it in mind when trying to apply ML to materials science (or to any other field), as similar routines might have already been developed, for instance, within the mentioned cryo-TEM community.<sup>177–192</sup> The cross-fertilization with not only other microscopy techniques, but other scientific and technical disciplines is of capital importance and is deeply discussed in the fourth section of this review.

## 2.2. Most important advances in spectroscopy

The previous section highlights the latest ML developments in the EM community to extract information from images. Even though we have seen strategies for dealing with high-dimensionality data such as 4D-STEM related techniques, most of the processes tackle 2D signals (mainly images). In fact, this is because computer vision has evolved fast in fields such as autonomous driving or macroscopic pattern recognition, in which the way to communicate the information to the computer is through digital imaging. Therefore, the processing of more complex data, such as the generated by Electron Spectroscopy (ES), still remains a challenge even more arduous than the previously reviewed EM image analysis.<sup>193</sup> This section shines light on whether the advances on spectroscopy can compare to the imaging ones, and in which situations the employed methods can share convenience. In the process, we pinpoint suggestions to push the development of these data types, trying to imitate the ascending trend observed in EM image processing. Indeed, opposed to ML for imaging, the reader may find, both in this review and in an autonomous literature research, a substantially smaller number of ML-related research works devoted to ES. By now, ES has mainly received a much simpler ML modelling, the architectures of which head the following subsections.

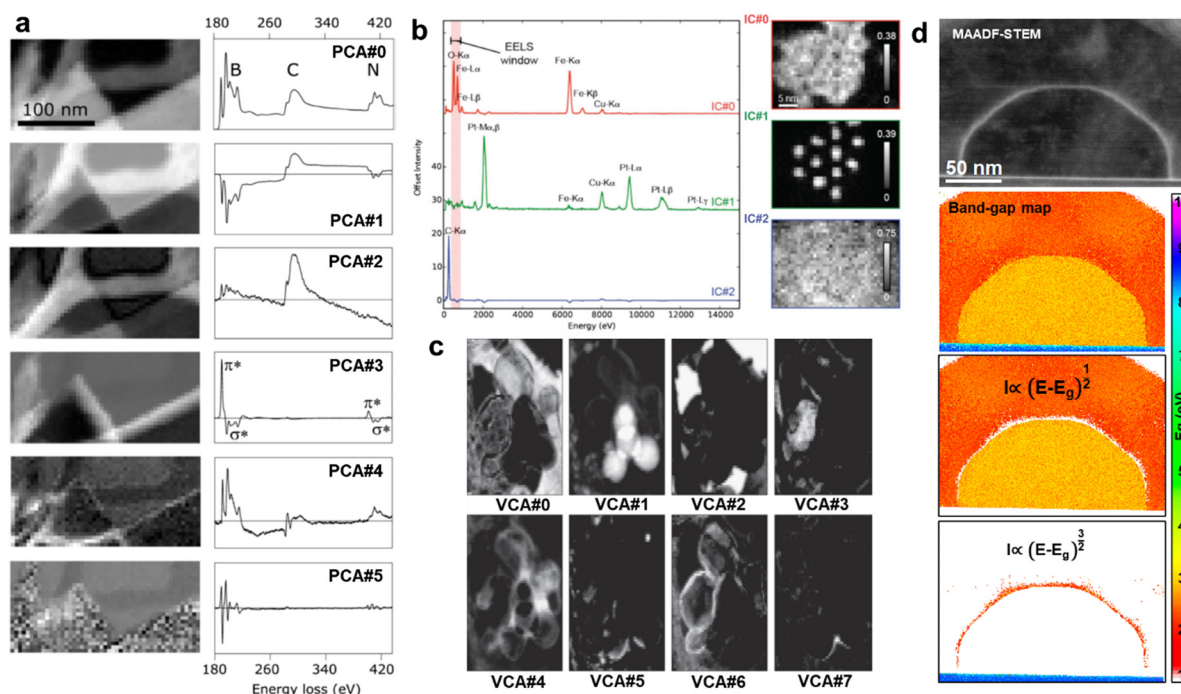
**2.2.1 Unsupervised machine learning.** Experimental ES setups typically lead to 1D or 3D datasets. Whilst a spectrum in 1D can hold unmeasurably valuable information, to take advantage of the high spatial resolution of the TEM, we will normally end up with 3D datasets. In fact, the main reason for choosing EM and ES should be exploiting its archetypical high spatial resolution, which will systematically result in the microscopist dealing with high-dimensionality data. Nevertheless, the generation of synthetic high-dimensionality data for training supervised models capable of dealing with these data structures is of immense complexity in ES. This is because it would require either gathering numerous similar experiments, or simulating them. Fortunately, the simulation routines to



generate reliable spectroscopic data are manifold in literature. Unfortunately, all these time-consuming routines would demand too many resources for generating a representative enough training set.<sup>194–198</sup> Moreover, its generated data would probably engineer a too case-sensitive model not capable of generalising and justifying the time and resources spent on generating this training data. Therefore, by now, the most popular routines to deal with spectroscopic data are the unsupervised ones. As happened with imaging, ES identified the limitations of traditional postprocessing and evolved by relying on ML. Representatively, either improving the effective energy resolution or increasing the SNR, postprocessing has always been of outmost importance in spectroscopy.<sup>199–203</sup> For instance, these improvements have been used to emulate the effects of monochromators without the costs of the hardware upgrade, or to spectrally distinguish electronic changes at the interface of a semiconductor heterostructure allowing to map a direct-to-indirect band-gap transition induced by a high epitaxial strain (Fig. 4d).<sup>204</sup> In imaging, for example, the denoising based on the non-rigid averaged cross-correlation of single atomic columns was used for both Energy-Dispersive X-ray spectroscopy (EDX) and EELS,<sup>1,205–208</sup> in addition to the denoising based on the

comparison between experiments and simulations.<sup>209–211</sup> However, none of these classical methods has been able to improve the SNR as straightforwardly as the nowadays standard post-acquisition operations based on Singular Value Decomposition (SVD).

As described previously, the first contact of ML with ES was precisely in the denoising of spectra *via* unsupervised unmixing methods. As a result, the examples in the literature highlighting the benefits, limits, associated handicaps, and mostly the direct routinary application of (mostly) PCA to ES data is really manifold.<sup>16,17,212–224</sup> The idea behind unmixing is the simplification of the spectral features and its description as a function of key physical properties such as material type or spatial distribution. Most of the unsupervised unmixing methods are variations or inspirations of SVD, which is currently an incredibly well-documented and accessible method that is worth relying on.<sup>225–227</sup> Its use decomposes the data into components that can be weighted in importance and reconstructed to dismiss any noise or inconsequential information (Fig. 4a). For example, SVD and its alternative methods can be used to clean atomic resolution EDX and EELS maps without significant distortions of the spectral fine structure.<sup>228,229</sup> Importantly, the chosen word “significant” is indeed significant, as special care must be



**Fig. 4** Unsupervised unmixing methods for hyperspectral analysis. (a) Principal Component Analysis (PCA) of a BN Electron Energy Loss Spectroscopy (EELS) Spectrum Image (SI) and the first six components, from top to bottom, with higher statistical significance. The presence of peaks and features of interest diminishes as going down in significance, where background or noise is the main feature. PCA does not physically constrain the components, as regarded by the negative losses.<sup>13</sup> Reprinted from M. Bosman *et al.*, *Ultramicroscopy*, 2006, **106**, 1024–1032 Copyright (2006), with permission from Elsevier. (b) Independent Component Analysis (ICA) of an Energy Dispersive X-Ray (EDX) SI of Fe-based core-shell nanoparticles with the three main independent components. The independence of the components mapped the cores (IC#1), the shells (IC#0), and the C background (IC#2).<sup>249</sup> Reproduced with permission of D. Rossouw *et al.*, *Part. Part. Syst. Charact.*, 2016, Copyright 2016 Wiley-VCH Verlag GmbH & Co. KGaA, Weinheim. (c) Vertex Component Analysis (VCA) of an EELS SI of BN/BO<sub>x</sub> nanoparticles, displaying the eight more important components. As the components were from the original SI, VCA was capable of mapping physically meaningful variations for each component such as particle edges vs. particle centres.<sup>250</sup> Reprinted from N. Dobigeon and N. Brun, *Ultramicroscopy*, 2012, **120**, 25–34 Copyright (2012), with permission from Elsevier. (d) Band-gap map of a ZnSe-ZnTe core-shell nanowire separating the areas where a direct or indirect band type was found. PCA was used on the low-loss SI to isolate the interfacial pixels between core and shell where the strain was accumulated, as visible in the Middle-Angle Annular Dark-Field (MAADF) micrograph.<sup>204</sup>



taken when unmixing signals and choosing the components to reconstruct. For that, P. Potapov and A. Lubk published a guide on how to automatically choose the meaningful PCA components.<sup>230</sup> It was based on an initial smoothing of the data followed by the evaluation of the anisotropy of the generated scree plot and its components. Finally, only those components not exhibiting the characteristic isotropy of noise are selected for the reconstruction. Related to this, the introduced statistical bias as a function of the truncated portion of the scree plot, total pixels and total energy channels was also extensively studied, facilitating the correct adoption of the method.<sup>225,226</sup>

We previously introduced that despite all the advantages of PCA, its main limitation is the lack of physical interpretability for its resulting components. To overcome so, alternatives physically constraining PCA became popular and demonstrated extended capabilities. In fact, the addition of physical constraints to ML is the logic evolution to follow in the coming years, both in the unsupervised and supervised domains. Among others, as introduced in the imaging section, we can find NMF, which forces the components to be positive, mimicking in this case the measured energies in ES; Independent Component Analysis (ICA), which only extracts statistically independent features assuming, for instance, that the spectral peaks for each element are not correlated; while contrarily, Gaussian Mixture Modelling (GMM) assumes that all the sources are governed by Gaussian distributions and separates the signals into a finite combination of these distributions; or Vertex Component Analysis (VCA), which assumes the presence of pure spectral signals, for instance, coming from pure materials, and evaluates their distribution through the hyperspectral dataset.<sup>231,232</sup>

Again, the literature referring unmixing methods for ES is vast. Specially from articles comparing, for a single application or for a similar purpose, some of these methods and confronting them towards finding the best performer.<sup>233–244</sup> In a general basis, NMF was the preferred way to proceed when the major goal lied beyond denoising or data inspection. That is because it can admit not only the direct physical significance of the extracted components, but to add additional constraints with ease. In this way, M. Shiga *et al.* broadened NMF by adding extra physical constraints that better imitate the statistical nature of both EDX and EELS. The constraints were the automatic prior-based component relevance and soft orthogonality determination, although these constraints can be tailored to more complex setups such as simultaneously acquired multimodal spectroscopy (multi-detector imaging, EELS, EDX, cathodoluminescence, . . .).<sup>245,246</sup>

Nevertheless, alternative unmixing methods do not necessarily need to substitute PCA or SVD, but to complement them. This is the case for ICA. After the pioneer work of N. Bonnet and D. Nuzillard on applying ICA to simulated EELS, ICA has been mainly used to complement PCA. In fact, N. Bonnet and D. Nuzillard claimed that ICA was a complementary technique to the standard unmixing methods, not a substitute, given that EELS does not fulfil the condition of statistical independence.<sup>247</sup> This complementarity can make use of PCA to avoid overfitting and next ICA can be used to spatially map crystal phases or elements.<sup>248</sup>

Following this direction, D. Rossouw *et al.* developed a compositional quantification routine based on dual-PCA + ICA and dual-EDX + EELS. To prove it, the authors tested their method on FePt@Fe<sub>3</sub>O<sub>4</sub> core-shell nanoparticles. Interestingly, they solved the quantification of the spatially overlapping core and shell phases with the complementary spectral unmixing, and the mapping of both light and heavy atoms with the complementary spectroscopy (Fig. 4b).<sup>249</sup>

The mixed use of PCA/ICA allowed to directly distinguish phases which would require an exhaustive and tedious least-squares fitting to be reproduced. However, the ICA assumption of independence between spectral peaks might cause artefacts when dealing with similar phases (*e.g.* sharing elements or oxidation states). This is where VCA can make a difference, as it succeeds at identifying the individual spectral profiles (*i.e.* combination of peaks) of distinguishable phases. VCA should then be used when the expected components already appear in isolated hyperspectral pixels representing a physically/chemically independent structure. This idea was validated in a comparative study carried out by, N. Dobigeon and N. Brun, who confronted PCA and ICA, least-square fitting and VCA. By requiring gentler statistical assumptions, the authors claimed the superior interpretability of VCA *versus* both PCA/ICA for the finer analysis of high-complexity sample configurations (Fig. 4c).<sup>250</sup> From this analysis we may get spatial information from the mapping of spectral components that are extracted by just looking at the energy domain. Therefore, spatial correlations, if present, may be ignored by just searching for similarities between spectra and not caring where the probe was. Alternatively, and in order to further account for spatial correlations within the SI, S. Kalinin *et al.* proposed an unmixing method based on spatial Gaussian kernels. These kernels were based on traditionally unmixed components that reduced the complexity of the energy domain and democratised the computational needs of the GP. The process can be understood as the convolution of the unmixed spectral features through the spatial dimension, leading into higher-fidelity reconstructions and mapping.<sup>251</sup> Interestingly, the authors demonstrate the ease to tune and adapt the kernels to a combination of unmixed components or to engineer them based on the physical characteristics we want to find from the hyperspectral dataset. As a result, this methodology was proposed as the preferred way to go if we handle highly spatially-correlated data (*e.g.*, core-shell nanoparticles, nanoparticle clusters, compositional gradients, . . .).

The main unsupervised routines used for ES, as commented, rely on unmixing methods. The decomposition in statistical components can be oriented to spectra denoising or cleaning, for unlocking a smoother post-processing, or even to map and quantify crystal phases and their stoichiometries. However, more intricate processes have been devoted to solve unattended matters such as spectral classification or the analysis of finer features such as the Energy Loss Near Edge Structure (ELNES). For this purpose, unsupervised clustering methods may represent an strategy worth relying on.<sup>252–256</sup> The idea behind spectral clustering is to automatically detect fine spectral changes and group them accordingly. As it is an

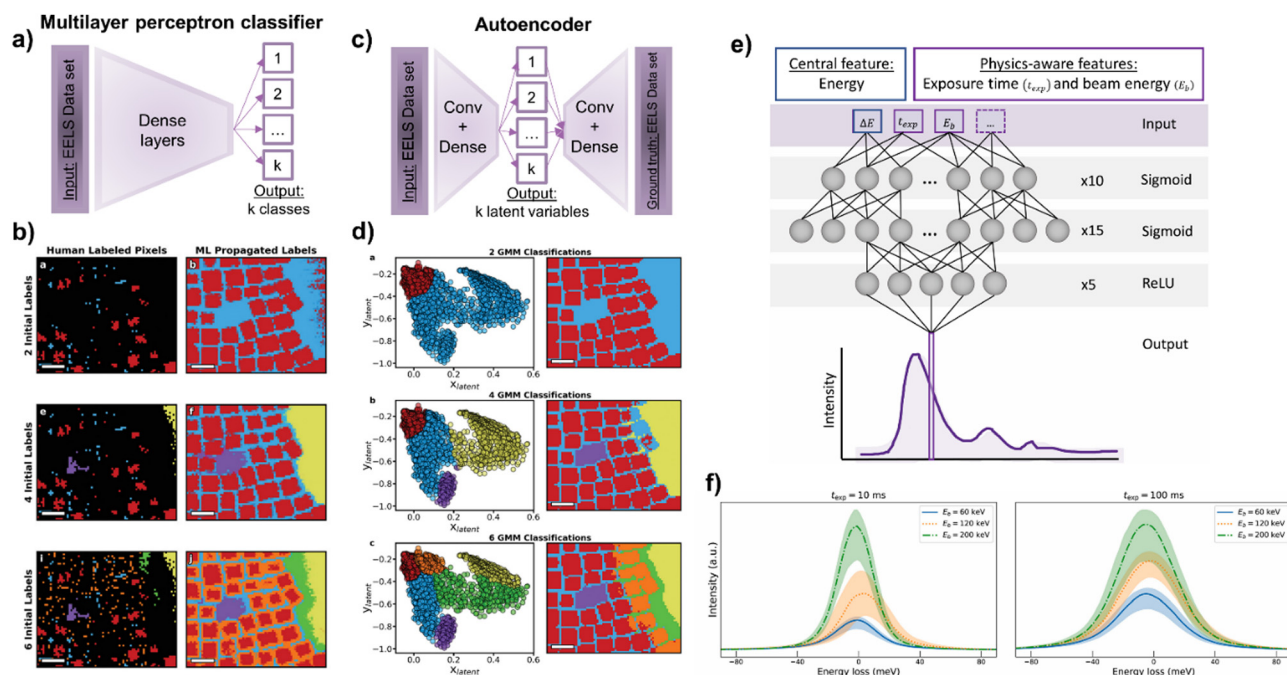


unsupervised method, it would require the manual tuning of a hyperparameter referring (somehow) to the number of final groups we want to have (for instance, the total number of different crystal phases in a Spectrum Image (SI)). For example, we can create a cluster for each spectra representing the different ELNES oxygen K edges. In fact, this kind of reasoning can act as the building block for elaborating models further. Representatively, S. Kiyohara *et al.* generated a decision tree (supervised learning) that dealt with the clusters representing the ELNES oxygen K edges.<sup>257,258</sup> As its name points, a decision tree is a supervised model capable of acting differently on its reference data depending on the way these reference data are structured. Interestingly, in this case, the reference data are directly the clusters representing the ELNES information. From that, the authors managed to, on the one hand, unveil the oxidation nature of oxides given their spectral description, and on the other hand, predict the spectra of a known oxide-based nanostructure.

The idea behind clustering is not far from unmixing, as we identify common patterns from spectra. Indeed, we can combine both to improve the identification of materials, either by applying PCA before clustering, or by applying it to segment each individual cluster.<sup>259</sup> In addition, this approach can be combined with non-linear least squares fitting for a deeper ELNES analysis that not only classifies the data, but unveils finer ELNES features such as valence, oxidation and coordination states. These options are

available online in the software solution dubbed WhatEELS, the use of which can be complemented with many other practical tools described in detail in the third section of this review.<sup>260</sup> In fact, clustering and unmixing are not exclusive for core losses and can also be applied to low-loss EELS, for instance, to map plasmons or even in the future to map with high accuracy the electronic properties of nanomaterials such as the topology of the band structure.<sup>204,261</sup>

Independently on the spectral range in which it was applied, the complexity of the ML reviewed so far for ES was standard. It is a good signal that in most of the cases this basic stage it is just enough. For the rest, more sophisticated routines are arising and will appear as the methodology reaches broader audiences. For that, a fruitful approach would be mimicking the progress done in EM imaging, where developing ML-based solutions might be more intuitive. In that sense, S. Kalinin *et al.* brought the idea of autoencoders from imaging to spectroscopy.<sup>82–85,88</sup> In a paradigmatic case, they deployed 1D convolutional autoencoders to unsupervisedly represent each spectral pixel into a set of only two latent variables. Afterwards, they grouped these outputted variables by GMM to distil the spectrally distinguishable regions of an heterogenous array of nanoparticles, in this case, composed of fluorine and tin-doped indium oxide (Fig. 5c and d).<sup>262–264</sup> Importantly, as happened on imaging, this research work and related<sup>265</sup> might draw the future of spectral analysis, and point it towards the implementation of



**Fig. 5** (a–d) Representations of S. Kalinin *et al.*'s work,<sup>262</sup> comparing two learning paradigms to unveil physically-distinguishable Electron Energy-Loss Spectroscopy (EELS) components. The authors suggested: (a) a supervised approach based on a multilayer perceptron capable of (b) extrapolating the partially manually labelled pixels of (b.a and b) two, (b.e and f) four and (b.i and j) six physically-different classes. On the other hand, (c) the authors proposed an unsupervised approach based on an autoencoder. (d) The autoencoder reduced the EELS dataset into two latent variables, which after being Gaussian clustered in (d.a) two, (d.b) four and (d.c) six classes, produced comparable maps to the supervised approach (b and d, reproduced with permission of S. Kalinin *et al.*, *Adv. Opt. Mater.*, 2021, **9**, 2001808 Copyright 2021 Wiley-VCH GmbH). (e) L. Roest *et al.*'s work,<sup>296</sup> represents the training of a physically-aware multilayer perceptron capable of (f) modelling a zero-loss peak and its uncertainty under different exposure times and beam energies.



more complex autoencoder-based routines, soft supervision, and the use of GAN architectures. Furthermore, this important last example from S. Kalinin *et al.* highlighted how different unsupervised (*i.e.*, the commented autoencoder) and semi-supervised (discussed below) approaches can lead to the same spectral analysis. For that, we discuss this revealing complementary approach further in the next section about supervised ES.

**2.2.2 Supervised machine learning and generation of training sets.** The previous section hopefully clarified the reasons why unsupervised ML would hitherto win in popularity *versus* the supervised in ES data analysis. The main limitation of supervised ML for ES lies in the arduous generation of training data. In consequence, the increase in accessibility of supervised solutions for ES must go hand in hand with a more straightforward and resource-friendly generation of representative synthetic labelled data. When we refer to labelled data in ES, we mean having either full spectra or individual energy channels linked to one or more quantities or properties. This could be, for instance, having a set of spectra and each of them having a tag indicating which elements they contain. Of course, this task requires a manual labelling done by a trained microscopist, or the simulation of spectra based on a known composition. Employing talent to label data should never be an option in these cases, and existing solutions such as mechanical Turks are neither elegant nor efficient for long-term perspectives. Current EELS databases foresaw this issue, but still do not provide answer to the labelling handicap, whose case-specific nature complicates the whole supervised picture further.<sup>266,267</sup> Nevertheless, the literature is full of multiple levels of theory, which can facilitate the generation of trustworthy simulated spectra.<sup>197,202,268</sup> In fact, the key for relying on simulated data is its ability to parallelly generate the labels (thus, paired data) considering the application of the eventual supervised model. For that, balancing the accuracy and efficiency of these simulations is a key step for planning this endeavour. The most time-effective approximations are based on classical electrodynamics and the dielectric properties of the materials, whose accuracy can be improved by adding quantum corrections.<sup>269–271</sup> The same can be applied to Monte Carlo simulations.<sup>272–275</sup> More accurate quantum calculations can be semi-empirical by the use of experimental scattering cross-sections, calculated by *ab initio* methods, or even estimated by ML.<sup>222,276–280</sup> High-fidelity simulations require multiple scattering (more efficient), with the FEFF code,<sup>281</sup> or *ab initio* computations (more accurate) of the sample potential in the multislice approximation,<sup>194–196,198,209,210,282,283</sup> or even by Bloch wave formulations in thin specimens.<sup>284–286</sup> Interestingly, these time-consuming approaches can reduce their cost by modelling the traditional pixelwise simulation of the probe displacement with scattering matrices.<sup>287</sup> Although these solutions were conceived with EELS in mind, the generation of EDX simulated spectra is equivalent but tailoring the potential for this interaction, modelling the bremsstrahlung background, and contemplating the specific detector geometry.<sup>271,288</sup> DTSA-II from NIST is an open tool that can be used to simulate EDX spectra, which also allows the analysis and processing of experimental spectra.<sup>289</sup> These tools are extended and detailed in Table 1.

Anyhow, these approximations can still be too computationally demanding for generating training data for 3D and 4D CNN. Promisingly, ML has already offered alternatives to EM simulation, such as the potential propagation through slices *via* the forward propagation of a trained neural network.<sup>120</sup> In this case, each slice in the multislice approach can be modelled with a layer of the neural network, as if the propagated weights were the actual propagated potential. This ML-based acceleration, together with the most efficient alternatives suggested could be enough to generate enough data for 1D analyses. Unfortunately, spatial correlations in SI would be majorly lost in this way, although the community already found ways to circumvent that.<sup>251</sup> Indeed, there is already research using 1D convolutions for dealing with SI, but 3D convolutions have solely tackled ptychography so far.<sup>138,262,290,291</sup> Importantly, the unsupervised example from S. Kalinin *et al.* would perfectly fill the gap of the simulated 1D data to emulate the spatial correlation of SI.<sup>251</sup> Therefore, this would dramatically reduce the costs of data engineering and model training while mirroring the expected advantages of 3D CNN (*i.e.* direct spatial correlations). Moreover, ML could still make the simulation scene evolve to reach simulation efficiencies that could unlock 3D hyperspectral datasets. For example, taking advantage of new ML paradigms such as graph neural networks (*i.e.*, supervised models for dealing with mathematical graphs). One idea is deconvolving the electron probe with the electrostatic potential encoded in trained graph neural networks, associating the atoms with the nodes and the bonding with the edges of these graphs. This inspiration from the multislice neural network may not be immediate, that is why more practical approaches resembling the discussed generative models are called to play a key role in the next years. Eventually, the desired paired data would be rapidly generated by these trained but tuneable generative models. A more complete picture about simulation and generation of data is found in Section 3 about the practical ML deployment for EM.

As reviewed, the ease of application and reliability of unsupervised methods in ES has hitherto left supervised routines to a second plane. Nevertheless, novel supervised ideas have been introduced to face more challenging cases, or even to have their performance compared with equivalent unsupervised methods.<sup>235,258</sup> At this point, it is very interesting to go back to S. Kalinin *et al.*'s work on autoencoders for categorising low-loss EELS.<sup>262</sup> A few paragraphs above we present an autoencoder plus GMM approach capable of mapping spectrally distinct regions in an SI (Fig. 5c and d). In the same manuscript, the authors presented a multilayer perceptron obtaining comparable results to the autoencoder. The idea behind this supervised model was the partial labelling of some pixels (spectra) of the SI and to base its training on the labelled pixels to infer the non-labelled ones. This labelling was done by assigning a class (element type and even chemical surrounding) to a fraction of the pixels belonging to this class. The authors evaluated the percentage of pixels that needed to be manually labelled for the correct supervised classification of the remaining unlabelled pixels. Surprisingly, they found that the well-chosen labelling of only a 0.31% of representative pixels led to an output





**Table 1** Main available software solutions for simulating electron microscopy images and spectra. The availability of a partner or complementary programmatic software can facilitate the generation of (labelled) datasets suitable for machine learning

|                               | Software solution                   | Level of theory                                                                          | Programmatic interface                 | Accessibility | Ref.                                |
|-------------------------------|-------------------------------------|------------------------------------------------------------------------------------------|----------------------------------------|---------------|-------------------------------------|
| Electron microscopy (imaging) | abTEM                               | Multislice, <i>ab initio</i> DFT bonding information + PRISM approximation               | Yes, Python-based                      | Open          | 343–345                             |
|                               | Bloch wave simulations              | Bloch wave formulation                                                                   | No                                     | Open          | 330 and 331                         |
|                               | Cerius2, Molecular Simulations Inc. | Multislice, molecular dynamics                                                           | No                                     | Paid          | 346                                 |
|                               | cudaTEM → cITEM                     | Multislice, independent atomic potential                                                 | Yes, command line                      | Open          | 347 and 348                         |
|                               | Dr. Probe                           | Multislice, independent atomic potential                                                 | Yes, command line                      | Open          | 349                                 |
|                               | Electron direct methods (EDM)       | Multislice, independent atomic potential + kinematic scattering                          | No                                     | Open          | 350                                 |
|                               | Multis                              | Multislice, independent atomic potential                                                 | No                                     | Open          | 330                                 |
|                               | Multivariate polynomial fit         | Multislice, independent atomic potential                                                 | Yes, Python-based                      | Open          | 337                                 |
|                               | Prismatic                           | Multislice, independent atomic potential + PRISM approximation                           | Yes, Python (PyPrismatic), C++         | Open          | 351–353                             |
|                               | QSTEM                               | Multislice, independent atomic potential                                                 | Yes, Python (PyQSTEM)                  | Open          | 354 and 355                         |
|                               | scikit-ued                          | Multislice, independent atomic potential + Kinematic scattering                          | Yes, Python-based                      | Open          | 356                                 |
|                               | STEM_CELL                           | Multislice, independent atomic potential + linear image approximation                    | No                                     | Open          | 357 and 358                         |
|                               | Tempas                              | Multislice, independent atomic potential + kinematic scattering + Bloch wave formulation | Yes, digital micrograph-like scripting | Paid          | 359                                 |
| Electron spectroscopy         | Bloch wave simulations              | Bloch wave formulation                                                                   | No                                     | Open          | 284–286                             |
|                               | DTSA-II (NIST)                      | EDX (characteristic and Bremsstrahlung) → Monte Carlo + $\phi(\rho z)$ + XPP             | Yes, command line                      | Open          | 289                                 |
|                               | Electrodynamics                     | Classical relativistic (faster) → quantum (more accurate)                                | Yes, command line                      | Upon request  | 269–271                             |
|                               | FEFF                                | <i>Ab initio</i> , projector-augmented wave                                              | Yes, command line                      | Paid          | 281                                 |
|                               | LEEPS (and variations)              | Monte Carlo + classical relativistic cross sections (faster) → quantum (more accurate)   | Yes, command line                      | Upon request  | 272–275                             |
|                               | PENELOPE                            | Monte Carlo + classical relativistic cross sections (faster) → quantum (more accurate)   | Yes, Python (pyPENELOPE)               | Open          | 360 and 361                         |
|                               | Prismatic                           | PRISM approximation                                                                      | Yes, Python (PyPrismatic), C++         | Open          | 351–353                             |
|                               | Semi-empirical calculations         | Experimental cross-sections or dielectric functions                                      | Yes, command line                      | Upon request  | 222 and 276–280                     |
|                               | WIEN2k                              | <i>Ab initio</i> , projector-augmented wave                                              | Yes, command line                      | Paid          | 194–196, 198, 209, 210, 282 and 283 |

comparable to the unsupervised autoencoder, validating the outstanding generalisation capabilities of DL (Fig. 5a and b). Remarkably, this approach facilitated the labour of training a supervised model for ES. Any microscopist wondering whether to invest resources on engineering a supervised model might just label a key fraction of the data to see how well an eventual model may generalise. It is excellent, then, to gradually put resources on model design and avoid massive resource investments unless it is mandatory.

This juicy research piece is not the only supervised approximation in ES. FCNN and support vector machines were also applied for automatic mapping and elemental identification, for ELNES characterisation, for instrument-independent spectral calibration, *etc.*<sup>290,292,293</sup> Nonetheless, these applications essentially resembled the reviewed unsupervised methods and their achievements. To be fair, the scenarios were more challenging, but the main workflow remained essentially unchanged. Indeed, the extra energy dimension that spectroscopy introduced, unlocks the in most cases missed opportunity to actively physically constrain the ML used. As happened with NMF *versus* PCA, where we force the maths to behave under some physical

logic, we want to directly make the ML aware of the science it would eventually represent. This is known as physics-aware ML and is currently scarcer than standalone supervised ML. However, it is called to be the next breakthrough in scientific ML. Interestingly, there are already some examples that are worth to comment and guide the reader on what can be achieved by following this path. L. Roest *et al.* tried to answer the repeatedly assessed universal modelling of the Zero-Loss Peak (ZLP) with a neural network trained on Monte Carlo simulations.<sup>294,295</sup> They generated a physics-aware model by adapting the regression model describing the ZLP (and its uncertainty) with the physical conditions of the acquisition, namely the exposure time and the beam energy (Fig. 5e and f).<sup>296</sup> This means that the input data the model received was the ZLP curve with the exposure time and beam energy, making these variables constitute individual dimensions within the parametric space of the model. Typically, the science awareness arises from directly inputting the physical conditions, although similar effects can be achieved with physically aware labels. For instance, one could use different unit cells, jointly simulate spectra and some physical properties, and train a model where the input is the spectra and the label is



the simulated physical property. This is what S. Kiyohara *et al.* did with a MultiLayer Perceptron (MLP) on core-loss spectra (*i.e.*, each neuron represented each energy channel) for the extraction of up to six properties (Fig. 2 MLP).<sup>102</sup> The training was performed on 1171 spectra, simulated by DFT from 188 different silicon oxides, and the labels were also simulated by DFT. Therefore, they eventually engineered a ML-based DFT simulator from experimental EELS spectra. From the input spectra, they were capable of extracting the physical properties they chose to generate the labels: properties such as average bond length and angle, Voronoi volume, bond overlap population, Mulliken charge and excitation energy.

Until now, the physics-aware approaches are based on simulations as the best way to directly link curves or images with a specific physical property. However, its implementation on experimental datasets would start with the reproducible and systematic acquisition of the metadata accompanying the experiment. In microscopy, the acquisition conditions and microscope parameters would be an already vast starting point. The works of L. Roest *et al.* and S. Kiyohara *et al.* shined light on the promising future of physics-aware ML in EM/ES.<sup>102,296</sup> Indeed, these are two of the few physics-guided ML models we can currently find among the EM literature. The importance of adding scientific constraints to ML not only does it turn in more general models, but can remarkably reduce the required training volume (similarly to rVAEs).<sup>88</sup> For instance, S. Kiyohara *et al.*'s work could be extended by training high-complexity DL models on full databases of spectra if a systematic spectra-property correlation was done. In addition, related to L. Roest *et al.*, a plural scattering remover could be trained with a dataset of dual EELS SI and then applied to correct only the core-loss spectral region of interest. Similarly, the energy resolution post-acquisition could be effectively improved by training a neural network on sets of the same spectra but acquired with different resolutions. Moreover, L. Roest *et al.*'s work highlighted the importance of the cross-fertilization with other scientific and technical fields, as the ML methodology the authors followed was inspired by equivalent solutions in particle physics. This cross-fertilization is further discussed in the final section of the review.

### 2.2.3 Compressed sensing and spectroscopic tomography.

As happened with imaging, CS is strongly linked to Spectral Tomography (ST). ML has also tried to mimic the CS functionalities in both reconstructing sparse SI and ST datasets. In fact, given the higher complexity of adding the energy axis into an already complex tomography reconstruction, CS and advanced data processing routines are more justified. However, let us first evaluate the use of CS for the relaxation of the acquisition conditions of traditional SI. Indeed, CS must be regarded as a complementary data processing method to the ML reviewed in the previous two subsections, rather than a substitute. The strategies for sparsity are based on reducing either the spatial or the energy sampling. The choice lies in identifying which is the most important dimension for the considered experiment (if there are abundant spectral features, we should just limit the spatial sampling, whereas if the beam scans through a lot of

variance, we should reduce the energy sampling).<sup>297,298</sup> For instance, full STEM-EELS SI were fully reconstructed from only acquiring the 18% of the total spectral pixels.<sup>159</sup> Importantly, the chosen basis of sparsity may strongly depend on the image features, but choosing it wisely may definitely boost the fidelity, dose reduction, noise resistance and efficiency of CS-based EELS sparse imaging.<sup>299</sup> Based on this, ML could be applied as a complement to automatically choose the appropriate basis given a training on a fast preliminary imaging step. In any case, the overall same ML strategies presented for CS-inspired imaging could be extended to ES with minimal adaptation given the extra energy axis, also taking advantage of mixed imaging-spectroscopy (High-Angle Annular Dark-Field (HAADF) + EDX) CS-enabled multimodal approaches.<sup>162,163,300</sup>

On the other hand, EDX, EELS and even Energy-Filtered TEM (EFTEM) tomography skyrocketed its progress in the last two decades.<sup>301–307</sup> Both qualitatively and quantitatively.<sup>308–311</sup> Even though its major advances in reconstruction algorithmics were not CS/ML-based, classic data processing established a starting point to which apply these new methodologies for refinement (majorly for EDX and EELS). As happened in imaging, the use of CS-based reconstructions overcame the effects of traditional reconstructions in managing the missing wedge. Even more given the additional energy channel and the requirement of DualEELS to avoid multiple scattering artefacts in ST.<sup>312</sup>

Interestingly, tomography may also benefit from CS-enabled multimodal approximations, namely STEM-HAADF and EDX with total generalized variation. The combination of complementary signals and their simultaneous regularisation (*i.e.* signal balancing) might be helpful for research cases where the separated techniques cannot reach the desired level of detail. For example, R. Huber *et al.* explored this method for the 3D reconstruction of nanostructures with both sharp edges and gradual compositional changes.<sup>313</sup> Despite the benefits of multimodal approaches, it can often be a time-consuming or dose-demanding methodology, even with the support of CS algorithms. Then, it may be even more interesting the use of unmixing methods as a pre-reconstruction step, following the leading work of L. Yedra *et al.*<sup>314</sup> PCA, ICA and VCA can be used to prepare the data for the posterior CS reconstruction. This initial unmixing step allows to reduce the reconstruction computational cost and its complexity by relaxing the prior assumptions, both for EDX and EELS, and under challenging sample configurations (Fig. 2 VCA).<sup>101,315,316</sup> Nevertheless, the ST processing is not limited to the pre-reconstruction and reconstruction steps. In fact, meaningful post-processing and cleaning routines might be applied after a reconstruction that has already met the benefits of the reviewed strategies. In the same way as DL was a successful tool used to denoise micrographs, it was also used to denoise EDX tomography reconstructions, following the original development in X-ray computed tomography.<sup>317</sup> To do so, A. Skorikov *et al.* trained a U-Net architecture on a set of 850 noisy EDX maps obtained on nanoparticles.<sup>318</sup> The DL denoising of the 2D maps outperformed traditional denoising methods and proved to be cumulative for 3D reconstructions of both simulated and experimental tilt series of metallic nanoparticles. As a result, EDX



tomography was rewarded with a much gentler trade-off between dose management and SNR.

Ultimately, this section reviewed the manifold ML techniques already used in ES. Nonetheless, its preliminary stage is stressed if compared with the variety presented in the imaging section. Therefore, the opportunities for applying the already developed methodologies to EDX or EELS are huge, but not only to these two techniques, but to EFTEM or even cathodoluminescence (CL). We were astonished to find absolutely no bibliographical match with ML for EFTEM or CL. In fact, the experimental similarities between EFTEM and, especially EELS, result in a theoretically straightforward implementation of its methods for energy-filtered imaging (despite its lately decreasing popularity), or differently, the use of CS for adding sparsity in the temporal axis of analytical tomography. Nonetheless, one of the most important ideas this section showed us is the potential of the inter-collaboration between different fields, as shown in the multidisciplinary work of L. Roest *et al.*, in this case towards physics-aware modelling.<sup>296</sup> Indeed, we cannot stress enough the importance of investing towards deeper physically-aware models aimed to simplify the nowadays too often unaffordable human and computational costs of developing complex ML models.

### 3. Tools to deploy machine learning in electron microscopy

The resources for applying ML to research are nowadays countless. For this reason, the present section is intended to be pragmatic. In the following we will discuss on the different resources concerning ML the reader interested in EM and ES may have access to. This includes software packages and code snippets which relax not only the required knowledge in coding, but in all the steps of the workflow. These steps consist of the (training) data preparation, the renting of high-performance computing time to run the models, the availability of already trained models or either the design of optimised architectures for a given problem, and even the final benchmarking. Therefore, those EM users willing to start applying ML methodologies to their research but also those more advanced willing to optimise their case-specific bottlenecks or barriers, may find useful resources in the following paragraphs. In fact, we will show that it is possible to develop a ML-based application for EM data analysis without an advanced knowledge on ML and not even with a big funding/infrastructure investment.

#### 3.1 Preparation of the training set

On one hand, we should closely evaluate the problem to solve and classify it. The possible categories can be data analysis or data acquisition automation, knowledge extraction, modelling and experiment optimisation, among other possibilities. Afterwards we should decide whether to go for an unsupervised, supervised or a semi-supervised approach. The decision will be mainly dependent on the ease to generate labelled data (*e.g.*, data accompanied with the ground truth of the expected classification), the data structure

and its orthogonality (correlations between variables), the task, and even the computational resources available. In the previous sections we have reviewed the major pros and cons of each approach, and the scenarios in which they better shine.<sup>319</sup> For example, in case we opt to follow a supervised approach to challenge the data preparation step, as previously emphasised, we should carefully plan the labelling step and not just rely on human workforce for doing this repetitive and tedious task. Therefore, as the first approximation to follow, we should self-engineer the dataset by using model-based methods or simulations to allow the automatic generation of the labels. In addition, special attention should be initially paid to the data format, and the current trends towards open and universal ML-intended data formats, such as the Universal Spectroscopy and Imaging Data (USID), based on hierarchical data formats like HDF5 or NumPy's native file type.<sup>320–323</sup> These formats are designed to intuitively store paired data and any metadata that could be used either to physically constrain our models or to be used as labels.

Data can be generated by means of very complex simulations but also through extremely simple ones. For instance, it is possible to simulate an atom image by calculating its electric potential by DFT and then deconvolving an electron probe to generate a micrograph. However, it is also possible to generate a circular feature (like a 2D Gaussian curve) and add some Poisson noise to have a simpler and cheaper (in computational terms) representation of the same atom.<sup>97</sup> Even further, although a bit circular, a properly trained generative model should be capable of outputting tones of synthetic atoms with the accuracy used for its training.<sup>324–326</sup> Of course, the utility of the latter would lie in having the generative model ready, thanks to someone else's previous efforts. In any case, the physical accuracy between these three approaches is incomparable, but the rudimentary model might be enough if it can represent the variability of the data of interest. At the end, ML can be seen as just an esoteric regression representing the variability of a dataset. If higher-complexity simulations are required, the resources available are manifold. Importantly, the label generation must always accompany the simulation, either with the same software or with a complementary custom script. In fact, this parallel automatic labelling is key to minimise the bias of a human labelling. For example, the pixelwise labelling of the compositional distribution of a qualitative EELS map will find pixelwise discrepancies if two different microscopists label them. Specially at the interface, the contrast and intensity of a pixel might be interpreted differently by two different expert microscopists. However, if a model was built and this interface was perfectly defined by a mathematical curve or function, the pixelwise labelling would be completely objective. Another example is the labelling of the central position of the atom we have previously simulated to create a model for atom finding. If it is an experimental STEM atom, the scan distortions may generate an odd intensity distribution. On the other hand, for a simulated atom, the central position is just the pixel closer to the spatial coordinate where we placed the atom in our model. Fortunately, this is independent on how we paint the





intensities within this atom. In other words, we are free to generate as much variability as we want.

The following simulation resources are precise but time-consuming. As a result, in these cases, the optimisation of the simulated volume is a priority. For instance, a handful of unit cells might be simulated and artificially spatially translated, rather than simulating a large area of the same repeated unit cell. For imaging, the multislice approximation is the most adopted and adapted solution: from the first formulation by J. Cowley and A. Moodie,<sup>327</sup> and E. Kirkland's first adaptation to STEM,<sup>268,328,329</sup> there are many solutions currently available, as summarised in Table 1, Electron microscopy (imaging). Most of these multislice solutions and Bloch wave codes perform similarly in terms of computing time and accuracy, thus the final choice mainly depend on our own interface implementation preferences.<sup>330,331</sup> Nevertheless, the Python-based codes might be more suitable for customising the parallel labelling step. For this purpose, existing Python packages can thoroughly facilitate the communication with atomistic models and crystallographic analysis.<sup>332–336</sup> Interestingly, STEM\_CELL and Prismatic offer simplified versions of the multislice algorithm with higher speed but reducing the precision (linear imaging, and combined Bloch wave-multislice, respectively). We can even find a multivariate polynomial fit trained on multislice simulations to provide a comparable accuracy in an up to six orders of magnitude faster algorithm than a CPU-parallelized multislice.<sup>337</sup> In addition, fast neural network-based computations mimicking *ab initio* calculations could be implemented in a more sophisticated approach for computing the specimen potential with existing solutions.<sup>338–342</sup> The same applies for the ES simulation (Table 1, Electron spectroscopy). The solutions and their particularities are presented in the previous section devoted to ML for ES, for which the labelling process would also demand a parallel script.

In case the application of interest cannot benefit from model-based labelling, we could instead take advantage of the already existing images or crystal databases. The goal will be finding the datasets in which the data structure resembles as much as possible our targeted data. Regarding images, this means having (or forcing) the same number of information channels (typically single, grayscale), number of pixels representing edges (learned convolutional filters may not detect edges or features represented by a different number of pixels), similar histograms and contrast/brightness descriptions, total number of pixels, the image calibration or resolution (if accounting for a physics-aware model), or the materials and morphologies illustrated. In these cases, the starting point can be the transfer learning of models trained on habitual and general computer vision databases (Table 2, General digital images). The idea is to exploit transfer learning with the datasets that resemble our data the most and provide a better starting point in the model training than just initialising the weights randomly or with the Xavier method.<sup>362</sup> In fact, despite the disparity between mainstream digital imaging and electron micrographs, this procedure reported advantageous results when training an ImageNet-initialised VGG-16 architecture used for the classification of HRTEM images of carbon nanomaterials.<sup>95</sup> However, EM databases may constitute

an even better starting transferable knowledge given the proximity of the variance of the data. The most interesting EM databases to initially use or work with are depicted in Table 2, Databases for electron microscopy images and spectra, where both unlabelled and labelled datasets are available free of charge. Complementarily, these micrograph databases could also be linked with crystal structures (e.g., encoded .cif files as the labels) for a rapid and automated crystallographic phase identification. This idea is represented in Fig. 6, where the development of this hypothetical application is schematically represented, requiring no specific coding ability nor extraordinary computing resources. The available crystallography databases to complete similar tasks are huge and are updated regularly. A summary of the available crystallography databases can also be found in Table 2. These databases thoroughly store the structural crystallographic information of manifold crystal phases. Interestingly, its format is suitable for encoding physically meaningful information in our models, such as cell parameters, space groups, chemical bonding and valence states, among others.

If we cannot either label *via* modelling or thoroughly rely on existing databases, we have no other option than labelling the data manually. After carefully planning the necessary training volume, one solution is the trivial manual labelling done by the researcher. However, it is not recommended, as the researchers' time is such a valuable resource that should not be spent in this repetitive task with no intrinsic nor transferable value. Alternatively, one may opt for a company specialised in preparing datasets for ML as another valid purchasable resource, as can be reagents, human talent or computing time. These companies excel in optimally augmenting and labelling the data of interest. Nonetheless, scientific labelling may require a trained eye. As a result, the labelling instructions should be clarified to reduce biases as much as possible, with a regular supervision of the results. Companies offer both tools for an optimised and intuitive manual labelling, and the labelling service itself: Amazon's mechanical Turk,<sup>387</sup> appen,<sup>388</sup> TrainingSet.AI,<sup>389</sup> Superb AI,<sup>390</sup> iMerit,<sup>391</sup> Clickworker,<sup>392</sup> ImageLabeller in MATLAB,<sup>393</sup> Sama,<sup>394</sup> or LabelMe Annotation tool,<sup>395</sup> among others.

### 3.2 Model design

As a matter of fact, the data generation step should always be accompanied with a decision on the model architecture. The description and purposes of the available unsupervised algorithms, models, supervised networks and architectures is out of the scope of this review article. There is plenty of information about it in the literature, and we summon the attentive reader to the review by J. Ede, which described in detail the most widely used architecture types in EM.<sup>92</sup> Generally speaking, CNN will be the preferred option for the EM data that can easily be structured as a vector, matrix or tensor (line spectra, images, SI...). Anyhow, assuming the architecture choice is appropriate, we can search for its code implementation, and preferably open source. One of the key intrinsic concerns of the Python language and specifically of the AI community, is the will towards open science. Gladly, this is translated into huge sources of open code for implementing any imaginable ML



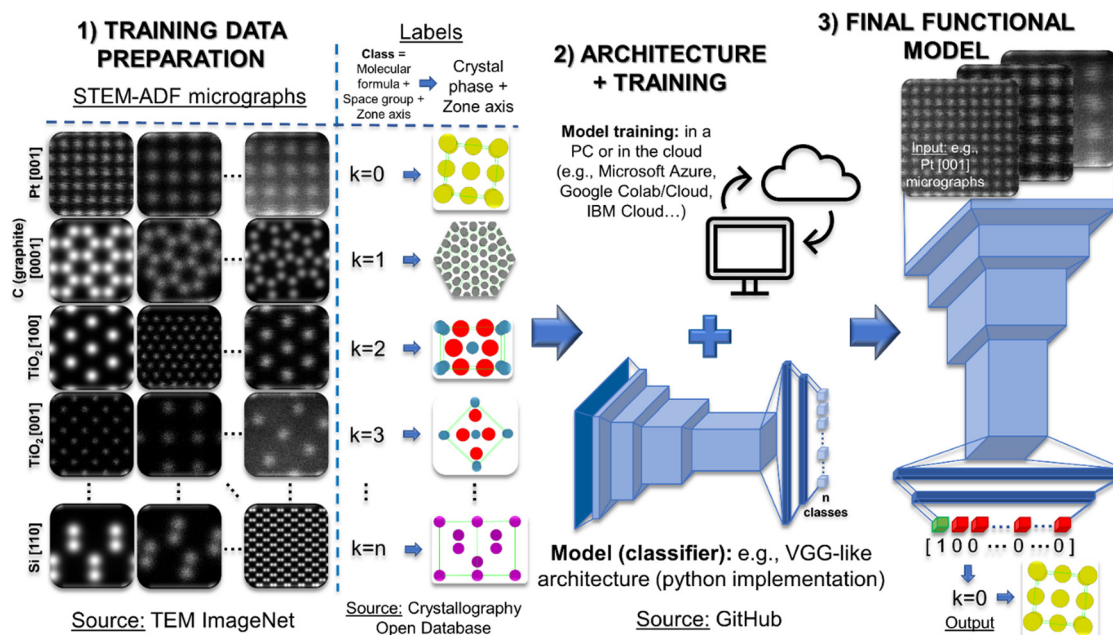
**Table 2** Main available databases for training supervised models on general digital images, exploitable in transfer learning, and specific databases containing electron microscopy images and spectra, and crystallographic information, for applications such as those depicted in Fig. 6

|                                        | Database                                            | Data amount (images)                                             | Content                                                                                                                             | Data type                     | Accessibility | Ref.        |
|----------------------------------------|-----------------------------------------------------|------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------|-------------------------------|---------------|-------------|
| General digital images                 | ImageNet                                            | > 14.000.000                                                     | Multiple categories of digital images (animals, vehicles, objects...)                                                               | Labelled                      | Open          | 363 and 364 |
|                                        | MNIST                                               | 70.000                                                           | Handwritten digits                                                                                                                  | Labelled                      | Open          | 365 and 366 |
|                                        | LabelMe                                             | > 4.000                                                          | City landscapes showing people, vehicles, objects...                                                                                | Multi-labelled                | Open          | 367 and 368 |
|                                        | ESP                                                 | > 350.000                                                        | All kinds of digital images and increasing                                                                                          | Multi-labelled                | Upon request  | 369         |
|                                        | Lotus Hill                                          | > 636.000                                                        | Multiple categories of digital images (animals, vehicles, objects...)                                                               | Multi-labelled                | Upon request  | 369         |
|                                        | Caltech101                                          | > 9.000                                                          | Multiple categories of digital images (animals, vehicles, objects...)                                                               | Labelled                      | Open          | 370         |
|                                        | Caltech 256                                         | > 30.000                                                         | Multiple categories of digital images (animals, vehicles, objects...)                                                               | Labelled                      | Open          | 371         |
|                                        | MSRC Kinect gesture dataset                         | > 719.000                                                        | Human movements and gestures                                                                                                        | Labelled                      | Open          | 371         |
|                                        | PASCAL                                              | > 19.000                                                         | Multiple categories of digital images (animals, vehicles, objects, gestures...)                                                     | Multi-labelled                | Open          | 372         |
|                                        | TEM ImageNet                                        | 14.000                                                           | – Simulated atomically-resolved STEM<br>– Multiple materials and orientations                                                       | Multi-labelled                | Open          | 373         |
| Electron microscopy images and spectra | EPFL EM dataset                                     | 1.065                                                            | Cell biology, experimental                                                                                                          | Labelled                      | Open          | 374         |
|                                        | Freiburg University ImageJ                          | 637                                                              | Cell biology, experimental                                                                                                          | Labelled                      | Open          | 375         |
|                                        |                                                     | Multiple sources > 30 TB in images                               | Cell biology, experimental                                                                                                          | Labelled and unlabelled       | Open          | 376         |
|                                        | CNR – IOM SEM dataset                               | 22.000                                                           | – Experimental images<br>– Low-dimensionality nanostructures<br>– MEMS                                                              | Labelled                      | Open          | 377         |
|                                        | Zelinsky Institute of Organic Chemistry SEM dataset | 1.000                                                            | Simulated images of nanoparticles                                                                                                   | Labelled                      | Open          | 378         |
|                                        | DeCost – Holm SEM dataset                           | 2.048                                                            | Simulated images of nanoparticles                                                                                                   | Labelled                      | Open          | 379         |
|                                        | Warwick EM dataset                                  | 135.375                                                          | – 19769 experimental STEM<br>– 17 266 experimental TEM<br>– 98 340 simulated exit wavefunctions                                     | Unlabelled                    | Open          | 380         |
|                                        | EELS DB                                             | > 200 spectra                                                    | Experimental EELS + XRD                                                                                                             | Unlabelled, but with metadata | Open          | 266         |
|                                        | EELS.info                                           | Sample spectra for every element                                 | Experimental EELS                                                                                                                   | Unlabelled, but with metadata | Open          | 381         |
|                                        | Crystallography open database                       | > 490.000 crystal structures                                     | Complete crystallography of inorganic, organic, minerals and metal-organic compounds<br>– Both experimental and theoretical studies | Unlabelled, but with metadata | Open          | 382 and 383 |
| Crystallography databases              | Inorganic crystal structure database, ICSD          | 60.000 crystal structures                                        | Complete crystallography of inorganic structures<br>– Both experimental and theoretical studies                                     | Unlabelled, but with metadata | Paid          | 384 and 385 |
|                                        | NIST crystal database                               | – 220.000 crystal structures<br>– 81.000 electron diffractograms | Complete crystallography of inorganic, organic, minerals and metal-organic compounds<br>– Both experimental and theoretical studies | Unlabelled, but with metadata | Paid          | 386         |

model. Fortunately, the EM community has followed this democratisation trend and has already provided open tailored solutions. Interestingly, these solutions come along with tutorials and intuitive guides both for newcomers searching for basic implementations and for experts wanting to carefully fine tune well-established models. For example, Pycroscopy (and its sub packages like AICrystallographer,<sup>404</sup> AtomAI,<sup>405,406</sup> GPax,<sup>407</sup> pyTEMlib<sup>408</sup>) offers a centralised platform of ML/DL pretrained models and raw architectures, among other analytical functionalities.<sup>320,405,409</sup> It provides a straightforward way to call and train models like U-Net or VAEs, as well as having their

weights initialised on EM/materials data (for transfer learning). On the other hand, the Materials Simulation Toolkit for ML (MAST-ML) provides a broader platform to boost materials-related research with ML.<sup>410,411</sup> DeepImageJ is its equivalent for biosciences, although the network architectures and weights might be exploited universally.<sup>412</sup> In a similar way, and despite it was originally intended for particle tracking in optical microscopy, DeepTrack 2.0 offers a pythonic solution to easily call ML/DL models.<sup>413,414</sup> This is why this might be the preferred choice for optical microscopy or biosciences applications. In this case, it also displays a user-friendly graphical interface,





**Fig. 6** Example of the hypothetical development of a Deep Convolutional Neural Network (DCNN) model to correlate Annular Dark-Field Scanning Transmission Electron Microscopy (ADF-STEM) images with the crystal phase and zone axis displayed. The Machine Learning (ML) workflow is thoroughly based on open software and resources, and requires almost zero ML-specific knowledge and funding/infrastructure. The ADF-STEM micrographs are taken from the TEM ImageNet open database,<sup>373</sup> with 14,364 images of multiple crystal structures. The images metadata correlates them with a class defined by the crystal phase and the zone axis (labels). The complete crystallographic information of the crystal phases is extracted from the free Crystallography Open Database.<sup>382,383</sup> Next, a VGG<sup>396</sup>-like architecture is used from an open-source<sup>397,398</sup> repository like GitHub,<sup>399</sup> almost eliminating the coding. The training can be done either in a PC or in a cloud service such as Microsoft Azure,<sup>400</sup> Google Cloud<sup>401</sup>/Colab,<sup>402</sup> IBM Cloud,<sup>403</sup> among others. Eventually, the model can be tested and used, allowing the user to identify the crystal phases and orientations of different micrographs.

with which newcomers will thank the interpretability of the deployable tools. Additionally, CDeep3M and ZeroCostDL4Mic work similarly, while offering the added possibility to run the code directly on cloud computers *via* notebooks.<sup>415,416</sup> The comprehensible tutorial format of these notebooks makes the implementation of the provided methods even more direct.<sup>417</sup> In addition, for those looking for CS tools, they can also be easily implemented with open codes like CSET<sup>418</sup> and RTSSTEM,<sup>160</sup> tailored for EM and its tomography.

The previous software packages are the formal answer to the community's need for straightforward and centralised ML/DL tools. However, if a given publication is inspiring us a specific architecture, one possibility is to directly dig into the article material. In this way, most of the papers developing a certain ML model contribute further with the code (and even datasets) towards reproducibility and for it to be applied in complementary research. Seldom do the authors protect their codes with private intellectual property. The proof is that most of the articles reviewed in the imaging and spectroscopy sections provide a GitHub or Zenodo link to freely download the represented code.<sup>399,419</sup> Indeed, these repositories, among others like OSDN,<sup>420</sup> Bitbucket<sup>421</sup> or GitLab,<sup>422</sup> have become powerful search engines to intermediary-free get open software and code snippets. Representatively, searching for “U-Net” in GitHub results in 27 732 resources (Search date: July 2022) that could be used instead of coding U-Net from scratch. Similar results are obtained by searching for the most well-known network architectures in

image analysis, VGG,<sup>396–398</sup> AlexNet<sup>423,424</sup> or YOLO9000,<sup>425</sup> among many others.<sup>426–431</sup> The use of one or another network will depend on the final application: we would use U-Net if we want a pixelwise classification of our image, but VGG-like architectures for classifying the whole image into a category. Alternatively, in case the research project demands a ML model not yet programmed nor shared, it could be coded from scratch. Obviously, this approach demands a higher understanding of coding and of the ML scheme. Nevertheless, the Python packages indicated in Table 3 offer intuitive programmatic interfaces to easily implement from the simplest unsupervised model to the most complex neural network. The most interesting or exploitable features of each are indicated in Table 3, although in a general basis, the beginner user would find a better ally in high-level APIs such as Keras, while the advanced user looking for further fine-tuning will benefit from low-level APIs like TensorFlow.

### 3.3 Training and testing

Once the (training, validation and test) data and the model are ready, the question is where to train the model. Generally, in DL the training volume is of about the 90–95% of the total data, while the test and validation set equally share the remaining 5–10%. This assumes that our data volume is large (*i.e.* 10 000 images or more). Nonetheless, these numbers are nothing but a guide towards best practises that can be modified depending on the total data volume. For instance, if our data volume is



**Table 3** Packages devoted to machine learning application, both in an unsupervised and a supervised way, and their main exploitation feature. The main environment for applying them is Python, although some of them also present APIs in other languages

| Package                        | Used for           | Programming interface/language/APIs                                             | Key feature                                                                 | Accessibility | Ref.        |
|--------------------------------|--------------------|---------------------------------------------------------------------------------|-----------------------------------------------------------------------------|---------------|-------------|
| Caffe/Caffe2                   | Supervised         | Python, C++                                                                     | DL performance and cross-platform deployment → features migrated to PyTorch | Open          | 432 and 433 |
| Ctypes                         | Un- and supervised | C/C++ → Python                                                                  | Use C/C++ libraries in Python                                               | Open          | 434         |
| Cython                         | Un- and supervised | C/C++ → Python                                                                  | Use C/C++ libraries in Python                                               | Open          | 435         |
| Dask                           | Un- and supervised | Python                                                                          | Scalability, parallelisation                                                | Open          | 436         |
| DL Toolkits                    | Supervised         | Wolfram Mathematica                                                             | Multifunction and interpretability                                          | Paid          | 437         |
| Gensim                         | Un- and supervised | Python                                                                          | For natural language processing                                             | Open          | 438         |
| GNU Octave                     | Un- and supervised | Octave                                                                          | Flexibility                                                                 | Open          | 439         |
| Hadoop                         | Un- and supervised | Apache                                                                          | Scalability, big data and parallel computing                                | Open          | 440         |
| Keras                          | Supervised         | Python                                                                          | Easy implementation of DL                                                   | Open          | 441         |
| Mahout                         | Un- and supervised | Apache                                                                          | Scalability                                                                 | Open          | 442         |
| MATLAB                         | Un- and supervised | MathWorks                                                                       | Flexibility                                                                 | Paid          | 443         |
| Matplotlib                     | Un- and supervised | Python                                                                          | Visualization and plotting                                                  | Open          | 444         |
| MXNet                          | Supervised         | Apache (integration with Python, Java, C++, R, Scala, Julia, Clojure, Perl)     | Scalability and interpretability                                            | Open          | 445         |
| Numba                          | Un- and supervised | Python                                                                          | Code parallelisation                                                        | Open          | 446         |
| Numpy                          | Un- and supervised | Python                                                                          | Flexibility                                                                 | Open          | 321         |
| OpenCV                         | Un- and supervised | Windows, Android, Linux, MacOS, FreeBSD, OpenBSD – C/C++, Python, Java, Android | Computer vision and image processing                                        | Open          | 447 and 448 |
| Pandas                         | Un- and supervised | Python                                                                          | Tabular data processing                                                     | Open          | 449         |
| Pattern                        | Un- and supervised | Python                                                                          | Web mining                                                                  | Open          | 450         |
| Pillow, Python Imaging Library | Un- and supervised | Python                                                                          | General image processing                                                    | Open          | 451         |
| PyTorch                        | Supervised         | Python, C++, Java                                                               | DL flexibility and rapid prototyping                                        | Open          | 452         |
| scikit-image                   | Unsupervised       | Python                                                                          | ML image processing                                                         | Open          | 453         |
| scikit-learn                   | Unsupervised       | Python                                                                          | Flexible ML built-in tools for data analysis                                | Open          | 454         |
| SciPy                          | Unsupervised       | Python                                                                          | Flexible general built-in tools for data science                            | Open          | 455         |
| Shogun                         | Unsupervised       | Python, JavaScript, C/C++, R, Ruby, Octave, Java, Scala                         | Multi-language support, ML data science                                     | Open          | 456         |
| MLlib                          | Un- and supervised | Apache Spark (integration with Python, Java, Scala and R)                       | Fast general ML                                                             | Open          | 457         |
| TensorFlow                     | Un- and supervised | Python, Java, C++, Swift                                                        | Highest flexibility, low-level DL                                           | Open          | 458         |
| Theano                         | Un- and supervised | Python                                                                          | DL flexibility and rapid prototyping                                        | Open          | 459         |

scarce because it is difficult to generate it, we will decrease the training percentage in favour of test and validation. At the end, these percentages could even be considered as hyperparameters to tune and will eventually be defined to maximise the overall performance. Practically, if the model and training volume is reasonable (*i.e.*, around  $10^6$ – $10^7$  trainable parameters and from 10 000 to 15 000  $512 \times 512$  images), the training time should mostly be a few hours in a regular PC with a GPU. Larger models, and even the generation of larger data volumes would require a larger computing infrastructure. For that, the ideal case scenario would be a partner institution placing computing systems at the researcher's disposal. In case this requirement is not met, then online and cloud computing services would instead be suggested. The following are the most established services for renting high-performance computing time, which most of them provide specific solutions for ML projects: Alibaba Cloud,<sup>460</sup> Amazon Web Services,<sup>461</sup> Microsoft Azure,<sup>400</sup> Deepnote,<sup>462</sup> Genesis Cloud,<sup>463</sup> Google Cloud<sup>401</sup> and Colab,<sup>402</sup> IBM Cloud,<sup>403</sup> OVHcloud,<sup>464</sup> and Paperspace CORE.<sup>465</sup> Whilst accessing powerful computing solutions is key to speed up the training-tuning cycle, the huge hyperspace susceptible to be modified can be overwhelming to face. To cope with that, we can nowadays find intuitive and powerful interfaces providing

insight and suggestions to optimise the training and hyperparameter tuning of our models (Weights & Biases,<sup>466</sup> and PerceptiLabs<sup>467</sup>). In fact, these solutions are not only intended for ML newcomers, as anyone looking for the effects entailed by the hyperparameter tuning of their models will benefit from these visualisation tools.

After training the model, the ML workflow is almost complete. The only step remaining would be the testing or benchmarking of the resulting trained model. At this point is when the dataset division into test and validation sets play a role. The test set will be used to iterate into the hyperparameter tuning till the test metric is maximised. Only then, the validation set is evaluated to output a final metric on the performance of the model on this dataset. This split into test and validation is not mandatory but recommended. With this, we reduce the bias of the final metric by avoiding the tuning of the model with the information that must serve the final metric. Apart from testing with our own data, it is recommended to evaluate the performance of the model with a standardised benchmarking dataset. Each community can formalise a dataset intended for a given purpose and make it the benchmark to follow when creating similar applications. For example, EM for cell biology received formal segmentation benchmark standards with a





platform dubbed EM-stellar.<sup>326</sup> Nevertheless, the feature complexity of the materials science EM data, along with the early stage in which ML/DL is currently in the field, turns into the absence of formal benchmarking tools. As reviewed, the applications achievable by ML methods are manifold, and each would require a specific benchmark routine. As a result, and until task-specific (or even more general task-agnostic) benchmark tools are standardised in EM, the best practice can be the strict evaluation of a representative test/validation set, by the most suitable metric given the aim of the model. Eventually, the model should be tested with the experimental data for which it was originally aimed. Complementarily, existing ML or general data processing tools can be useful to crosscheck the performance of our trained model. This can be both a substitute for absent benchmarks and a validation tool for successfully benchmarked models. For instance, if our model is devoted to crystallographic analysis or phase identification, we can use the powerful CrysTBox for a quick validation.<sup>468</sup> If our model is for 4D-STEM data processing, we may additionally use Py4DSTEM<sup>469</sup> or Pyxem<sup>470–472</sup> for corroboration. In case our developed model tries to automate a particular step of the TEM data acquisition, maybe combining it with the ANIMATED-TEM toolbox allows us to reach the next level of overall automation.<sup>473</sup> On the other hand, if our application is intended for image or spectra analysis, it may benefit from double-checking the results manually in one of the many data processing software available, among which we highlight the broad capabilities and open philosophy of gempy,<sup>474</sup> LiberTEM<sup>475</sup> and HyperSpy.<sup>476,477</sup> More specifically, if the goal of the trained model is general STEM strain analysis, we can crosscheck it with Fourier-space phase analysis and with real-space atomic position determination, or even with Moiré fringe imaging or the simulation of lattice elasticity relaxation.<sup>7,8,478</sup> For instance, among the real-space analysis we find traditional and well-established methods such as Atomap,<sup>99,479</sup> ranger,<sup>1,10</sup> qHAADF,<sup>480,481</sup> iMtools,<sup>482</sup> StatSTEM<sup>2</sup>, or oxygen octahedra picker,<sup>483</sup> but also ML/DL-based methods (e.g., atomic column finding), which can be even more indicative of the state of the art for comparison purposes.<sup>6,15,59,97</sup>

The tools and resources reviewed in this section are meant to make the electron microscopists' life easier. In fact, ML routines can be fully developed thanks to them, requiring little resources to make brand new models come true, as depicted in Fig. 6. Nevertheless, these are the tools that are currently being used or have been developed or adapted mostly by the EM community. Therefore, there is plenty of room at the bottom for introducing new models and architectures yet unexplored in EM. For instance, the need for rapid and trustworthy dynamical simulations has catapulted the popularity of graph neural networks.<sup>484–488</sup> Interestingly, the structure of the EM data could perfectly fit these flexible networks, allowing to point towards dimensionality-independent models. Even (deep) RL (already reviewed for a couple of applications<sup>107,122,163</sup>), key in robotics and in videogames design, could be the major breakthrough for the complete TEM automation.<sup>489,490</sup> These and many other ML developments not yet implemented in EM are reviewed with further attention in the next section.

## 4. Inspirations from other fields for future developments

The previous sections described manifold EM applications and how the numerous available ML methodologies pushed towards thrilling advances in the field. Nevertheless, the reviewed potential of ML is just the tip of the iceberg of everything ML has to offer. The best way to realise this fact is by the examination of the significance of ML in other fields where it is not a complementary resource but a keystone. As promised, this section is intended to evaluate the ML-based case studies in these other fields and the way they could be beneficial to EM in order to solve materials science questions in the near future. Importantly, it is easy to repeatedly consider the following results as robust starting points for tailoring specific experiments to the materials/EM community. Or the other way around, the previously reviewed developments could be extrapolated to these fields to strengthen them even more. In fact, both the electron microscopists and materials science researchers, but also domain experts from the specified fields may benefit from the ideas discussed below. The ideas and findings discussed throughout the section have been schematised as a guide in Fig. 8.

### 4.1 Microscopies and imaging

**4.1.1 Cryo-EM.** The Nobel prize-worthy technique for the structural reconstruction of proteins, viruses and other macromolecules demands working with huge amounts of data. It is fundamentally based on the electron (diffraction) tomography or single particle reconstruction from images and/or diffractograms acquired from hundreds of crystals containing the molecule of interest.<sup>491,492</sup> An important step of the workflow is the search for the single-crystalline particles containing the target biomolecule, from where the images are going to be acquired. The process of selecting the particles of interest can be laborious and bottleneck the whole workflow. As a result, tons of efforts have been allocated to its automation. In fact, this automation constituted the angular stone in extending the reach of cryo-microscopy, consequently settling it down. This is because the obtention of multiple equivalent projections from different particles allows to match them together and to improve the resolution. Multiple ML methods such as support vector machines, logistic regressions, *K*-means clustering, classification trees, or deep CNN attempted to automate this process.<sup>183,192,493–496</sup> Interestingly, deep neural networks were successfully used to automatically guide the microscope in procedurally finding the carbon holes, single particles inside, and eventually acquiring the different image projections for their final projection matching.<sup>178,189</sup> It is great that this was achieved by directly applying the wide-spread YOLO network architecture, reinforcing the message we wanted to spread out in the previous section about the ease to deploy ML in microscopy despite the scientific background. Interestingly, this approach could be directly exported to general TEM to automate the region of interest finding for any material or nanostructure (as with ANIMATED-TEM<sup>473</sup>).



Moreover, autoencoders were also used to detect those single particles orientation and help with the optimisation of the 3D reconstruction step, similarly to S. Kalinin *et al.*'s work.<sup>84,88,497</sup> In fact, ML and DL was used to improve the reconstruction of the tilt series. Remarkably, this ML-based improvement unlocked new fidelity landmarks allowing to decipher the secondary structure of proteins.<sup>180,498,499</sup> To achieve it, D. Si *et al.* used support vector machines, while R. Li *et al.* used a CNN instead, obtaining comparable results.<sup>191,500</sup> As happened with region-finding automation, these approaches can be used to improve the resolution of materials ET, and to make it gentler, as observed with CS.<sup>142,146,148</sup> In fact, CS, which was extensively used for materials science, is just testimonial in cryo-EM. Therefore, CS may be a way to improve the biomolecule reconstruction further, even with ML algorithms mimicking CS, by relaxing the total dose and data necessary to complete these reconstructions.

**4.1.2 Optical microscopy.** A document even larger and denser than the present contribution could be created by reviewing ML in optical microscopy and all the derived techniques that fit in this field. Most of the recent advances combining some sort of AI with optical microscopy aim for image segmentation. That is, separating distinctive regions in micrographs such as different cell types, steels grain boundaries, or the planar extent of 2D materials (Fig. 7). This distinction will be mainly represented by differences in the intensities of the micrograph. This means that the main parameter to exploit for the segmentation is the value of every pixel, although using the pixel coordinates within the image and neighbouring pixel correlations will be recommended, too.

Specifically for biosciences, contouring and drawing the cells area is of paramount importance for multiple studies such as the cell division and the cell cycle, or cell dynamics and the interactions with substrates. Doing it in an automated way is therefore a requirement to obtain representative results over large populations of cells.<sup>501</sup> One of the main challenges is that cellular and subcellular features are complex and diverse in morphologies and textures. This problem would hamper the implementation of a robust unsupervised solution. As a result, supervised (mostly CNN) approaches are excelling in this job in contrast, fluorescence, and super-resolution microscopy, among others.<sup>502–510</sup> For that, the idea we have widely reviewed on simulating data that resembles the variability of our target micrographs is also valid here. For instance, A. Sekh *et al.* followed the idea of physics-based labelling by simulating fluorescence microscopy images out of the simulated 3D geometries of organelles (Fig. 7).<sup>511</sup> The authors proved the viability to train a subcellular DL segmenting tool on simulated data with a workflow that faithfully resembles most of the supervised routines reviewed in atomic resolution STEM. At the end, it is important to remember that the original U-Net was designed for cell segmentation!<sup>65,512</sup>

The reach of ML-based segmentation in optical microscopy is broadened when applied to materials science. For instance, in metallurgy it is a common practise to image steels and locate and quantify the spatial extension of their phases and grains. Furthermore, it is common to extract statistics on the total area

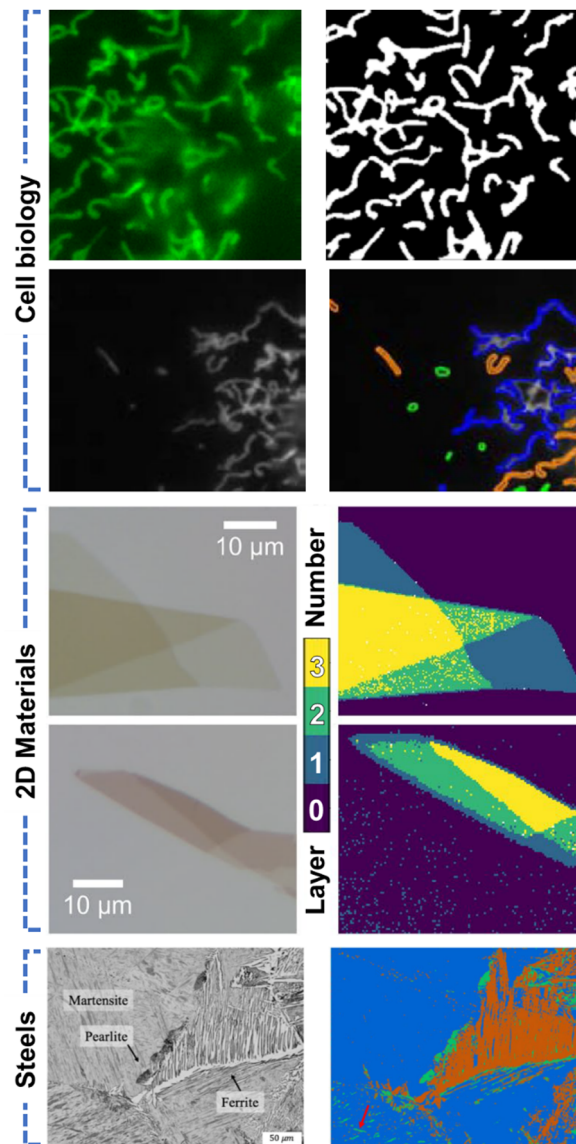
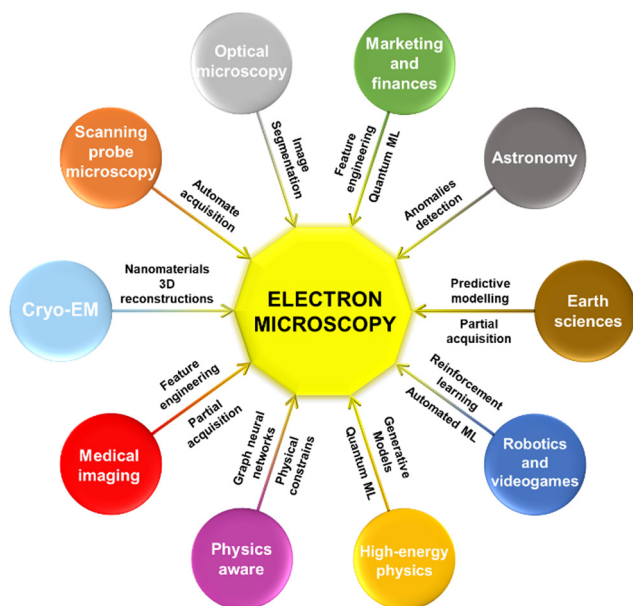


Fig. 7 Segmentation of optical microscopy images of cells, 2D materials and steels. The cells were imaged with fluorescence microscopy and segmented using a neural network trained on synthetic 3D models of cells simulating the imaging conditions.<sup>511</sup> The optical microscopy of stacks of 2D materials like MoS<sub>2</sub> were unsupervisedly segmented and classified to map the number of stacked layers.<sup>513</sup> The same applies to optical images of steels and its different phases. This case is a combination of the previous two: the authors segmented the images with a trained convolutional neural network and classified the steel phases with an unsupervised clustering algorithm.<sup>514</sup>

synthesised when optimising the growth of 2D materials, the automation of which is welcomed. In these cases, the complexity of the imaged features perishes in comparison to those imaged in biosciences. Therefore, these simpler features allow unsupervised routines to succeed. For example, the number of layers of stacked graphene or dichalcogenide sheets and the micrograins of steel can be automatically counted and mapped with clustering-based segmentation (Fig. 7).<sup>513</sup> In addition, postprocessing can be applied to the segmented data if an end-to-end application is





**Fig. 8** The cross-fertilisation between the listed disciplines and electron microscopy for materials science can entail the next breakthroughs in the field. This can happen both by the direct collaboration between specialists and by just the inspirational nature of the newest literature. In a potentially bidirectional scientific flow, the scheme considers the most important knowledge transfer that might arise from the reviewed fields towards electron microscopy.

sought. An example of this is the semi-supervised approach followed by H. Kim *et al.*, who mixed a CNN-based segmentation and simple linear iterative clustering to firstly, identify, and afterwards classify the microstructure of experimental optical images of steel (up to fields of view of about 1 mm) (Fig. 7).<sup>514–516</sup> This example highlighted that, as mentioned, the automation makes the statistics extraction and the handling of large regions of interest realistic. Nevertheless, its application to EM and materials science might not be so straightforward. The idea of segmentation is a bit more abstract in EM, as the features presented strongly depend on the magnification, and there are multiple magnification intervals providing meaningful information. Thus, the techniques to be used for segmenting the atoms in an atomically resolved micrograph will differ from the segmentation of a large field of view where no atoms appear. Consequently, the reviewed segmentation approaches for optical microscopy could be beneficial for EM experimental setups exploring the morphology of nanostructures and nanodevices, as in the case of SEM and low magnification (S)TEM. This is because these would be the EM situations that better mimic the scenarios handled by optical microscopy, with immense fields of view being analysed. Indeed, both industrial processes and other tedious counting steps would take valuable advantage from it. Importantly, the sparsity of the EM features would likely demand a supervised model to attain robustness. Hypothetically, the first step towards this time-saving model could be transferring the learned weights from the optical microscopy models reviewed here. Unfortunately, the additional generation of the necessary meaningful ground truths to complete the training remains an open challenge, by now.

**4.1.3 Medical imaging and diagnosis.** Radiomics is the study of medical images and their features to uncover shared patterns within related diseases.<sup>517</sup> Its main objectives are the risk assessment, the diagnosis and the prognosis (*i.e.* prevention) of (virtually every) imageable pathologies.<sup>518,519</sup> Among others, the imaging techniques include computed tomography scan, positron emission tomography or Magnetic Resonance Imaging (MRI), to address multiple diseases such as cancer, neurodegenerative diseases, or more recently lung damage caused by Covid-19.<sup>520–523</sup> From the reviewed methods, we know that ML excels in extracting features from data. In addition, it turns out that one of the key points of ML-based radiomics is the generation of meaningful features out of the data to feed richer ML models. These features are descriptors derived from the intensity distribution of the image, as discussed later. Actually, a great strategy to improve the prognosis of these ML classifiers is the enlargement of the feature space. Long story short, to get more meaningful information (features) out of the images. For instance, C. Chen *et al.* and H. Kniep *et al.*, artificially enlarged the feature space of MRI to up to 43 and 1423 image features, respectively, to distinguish between metastatic and non-malignant brain tumours.<sup>524–526</sup> Both the feature enlargement and its classification could be done by ML, and both offered promising results for predictive medicine.

The studies augmenting the feature space are abundant, but all share the emphasis on capturing the images texture.<sup>527–529</sup> By texture the researchers refer to different ways to deal with the pixels intensity to convert it into potential features.<sup>524,530,531</sup> For instance, the intensity histogram and the segmentation of the images and its resulting shapes could be considered as additional straightforward features. Moreover, not as direct local descriptors such as the grey-level co-occurrence matrix or the neighbourhood grey-level dependence matrix proved helpful.<sup>525</sup> Indeed, the powerful idea of adding meaningful extra features to the EM data is a synergy that it is worth exploring. This is because most of the explored articles just relied on the intensity as “the feature”, and only occasionally was it accompanied by additional channels of information. Being careful about the statistical significance of the added features to avoid overfitting, this approach could potentially benefit especially unsupervised routines in EM. This approach could start with the simple stacking of, for example, multiple edge detection filters as fake channels of the original image. Furthermore, we could even add multiple DL segmentation routines or higher-complexity image processing as the added features. Interestingly, within an interactive exploratory workflow, additional features could be progressively added till the model is found to overfit, and then to progressively constrain these features towards a more robust eventual unsupervised model.

**4.1.4 Scanning probe microscopy.** The previous sections showed that certain developments involving ML in STEM were closely inspired by previous works on SPM, specially STM, and *vice versa*. In fact, some ground-breaking data analysis techniques were general enough to allow a positive proof of concept in both STEM and STM simultaneously.<sup>59,81</sup> This healthy cross-feeding could meet new horizons with the implementation of the





following trends in SPM automation.<sup>532,533</sup> We could hitherto find little research done in segmentation and SPM data analysis involving ML (thus it could heavily benefit from the routines described for optical microscopy and EM, respectively), whilst the ML-based approaches for SPM automation are manifold.<sup>534–537</sup> This is justified given that the main bottleneck in SPM could be considered the actual data acquisition and the preparation of the experimental setup. In summary, the whole SPM automation is based on optimising the tip-sample interaction. Moreover, that interaction and the resulting data must be evaluated to accept it or not as an appropriate source of data. For this purpose, automatically assessing the tip quality for its conditioning becomes a key first step. In fact, M. Rashidi and R. Wolkow, and S. Wang *et al.* trained neural networks to automatically identify tip artifacts in imaging and spectroscopic STM, respectively.<sup>538,539</sup> Thanks to that, and beyond tip characterisation, the next step could be the ML-fulfilled conditioning of the tip based on this automatic assessment. This can be done either by directly fabricating the tip, as exemplified in B. Li *et al.*'s work, or by functionalising it with, for instance, carbon monoxide molecules to enable molecular imaging, as in B. Alldritt *et al.*'s work.<sup>540,541</sup> Most of these works rely on the partial data acquisition for extracting the minimum necessary information quickly, closely resembling what reported for CS in STEM and ET.<sup>542</sup> This idea could be extended further to the automation of the electron microscope and in high-throughput sample preparation layouts based on automated focused ion beam.<sup>543,544</sup> Interestingly, the tip evaluation could be turned into the analysis of artifacts in the acquisition of EM, and its decomposition into a probability distribution stating the likelihood of these artifacts coming from a malfunction of the tip, some dirty aperture, or maybe just the aberrations of the lenses.

A similar idea is recurrent in Atomic Force Microscopy (AFM), although most of its ML studies are devoted to optimise the extremely time-consuming analysis of force–distances curves.<sup>545,546</sup> These curves arise when testing the proteins superstructure in tension/elasticity experiments, with the binding/unbinding of proteins or macromolecules that interact with each other, after the indentation of the tip into cellular and subcellular structures, or into organic molecules and inorganic materials. The typical workflow is then to fit these curves into a possible model that explains the (bio)physics behind the interaction. Of course, this may end up in a time-consuming iterative process guessing the most close-fitting assumption. Nevertheless, the advances in ML allow to automate its analysis by fitting the data with trained models. In fact, this process was automated by training neural networks both to fit the curves and to generate test models, therefore accelerating the model-experiment correlation.<sup>547–549</sup>

Interestingly, the tackled experimental setups of atomic force microscopy share the fact that they induce some degree of modification to the sample, either by digging a topological hole in a wafer or by stretching the ternary structure of a protein. Therefore, these time or effect-resolved analyses would fit properly in the framework of *in situ* EM experiments. The conversion of the acquired *in situ* datasets into a data format

equivalent to force–distance curves would allow the immediate exploitation of these already built-in model validation tools. As a result, EM experiments correlating time and beam-damaged area, voltage and domain orientation, or gas pressure and growth ratio, would instantly have their analysis automated when matched with the workflow provided by atomic force microscopy and its accessory techniques.

## 4.2 Big data and physics

**4.2.1 Astronomy.** ML in astronomy discovery is a pillar in practically all its subfields, and becomes a source of hope for the next decades advances in the field.<sup>550,551</sup> Astronomers, accustomed to dealing with huge datasets of up to many terabytes, embraced data mining as the only viable route against increasing data volumes.<sup>552,553</sup> Paradigmatically, only a fast literature search involving the “ML” and “astronomy” keywords is required to reach many research articles involving the advanced use of 3D CNN.<sup>554,555</sup> The fact that convolutional filters of higher than two dimensions appeared just once (for ptychography) in the reviewed EM bibliography, emphasises the power this synergy may have in, for instance, dealing with 4D STEM and hyperspectra.

The detection of *a priori* hidden features or patterns in data is of outmost relevance in the characterisation of the outer space.<sup>554–557</sup> Finding new galaxies, black holes, dark matter and even dark energy is driving astronomers mad, and the ML tools are helpful on this crusade.<sup>558–560</sup> For example, neural networks and decision trees proved useful for detecting black holes in globular clusters, dark matter in strong-lensing systems, and even for gravitational wave sensing.<sup>561–563</sup> These examples could fit into the category of anomaly detection, which has not been formally explored in detail in EM yet. The concept of anomaly detection is quite self-explanatory, being key in multiple scientific, technical or business fields, as finding and understanding outliers is inevitably a source of knowledge. Besides, as ML excels in finding patterns or regressions in data, just by complementarity so does it to find data that deviates from those found regressions. Other astronomy applications that also shine light on the potential of ML anomaly detection are the spotting of extragalactic transient astronomic events (*e.g.*, supernovae), the refinement of supernovae simulation through anomaly detection and correction, or even the general searching for any anomaly in any dataset in the so-called “Systematic serendipity”, among others.<sup>564–567</sup> Moreover, an especially interesting field of application is the detection of exoplanets or near-Earth objects watch (*e.g.*, asteroids and comets), and the premature detection of those having orbits with potential impact hazard to the Earth.<sup>568–571</sup> Not surprisingly, CNN excelled in the detection of both exoplanets and asteroids, again confirming their versatility.<sup>572–575</sup>

Importantly, these ideas closely bonded to anomaly detection would fit in the EM framework with ease. Some would say that some of the applications reviewed would fit in the anomaly detection category, but as said, the truth is that the concept hardly ever appeared formalised in EM studies. At least not until P. Cho *et al.* developed an anomaly detection method





combining PCA and CNN for detecting point defects in atomically resolved micrographs.<sup>68</sup> Interestingly, the authors could generate heatmaps highlighting the image regions in which the presence of defects (*i.e.*, anomalies) was more likely. As mentioned, so far, we have reviewed a few EM studies that operated similarly, but none performed as maturely as the surveyed examples in astronomy. It is not about being picky about the wording given to every application, but to have the anomaly detection routines in mind as tailored solutions for problems like the point defects example. For instance, the astronomy example holding the comparative and cooperative training between anomaly-free and anomaly-full datasets would not even be thinkable unless the anomaly detection concept was deeply implanted in the researcher mindset.<sup>567</sup> Indeed, the defects detection idea could be opened up further to interpret any lattice distortion or strain: a model trained on a perfect regular atomic lattice (anomaly-free), complemented with a model trained on a distorted lattice labelling the strain and the defects (anomaly-full). On the other hand, in an EELS edge identification model, the anomaly-free set could be represented by a smooth background, with the anomalies being the core-loss edges themselves. Or even subtler with the edges acting as the main signal and the anomalies being the edge shifts or near-edge variations, in a finer chemical analyser.

#### 4.2.2 High-energy physics

**4.2.2.1 Classical methodologies.** The idea of doing a final fourth section comparing the state of the art of ML in EM with its state in other fields has its roots in astronomy, but also in high-energy physics. Since its origins, the uninterrupted massive data flow coming from particle colliders demanded special data processing tools, as in astronomy. Again, ML embraced this labour fitting well for necessities such as the adoption of generative models to provide a real-time answer to simulations on the detector response, to accelerate the exploration of parameters based on the matrix element method, or to allow the analysis of the rawest data, such as raw detector hits, in end-to-end models.<sup>576–580</sup> These cases constitute narrow field-specific problems with a hard to establish equivalence to EM. However, the aspect that receives most of the attention, and that is also easier to link, is the analysis, identification, discrimination and classification of the collisions themselves and the resulting particle jets and showers.<sup>581,582</sup>

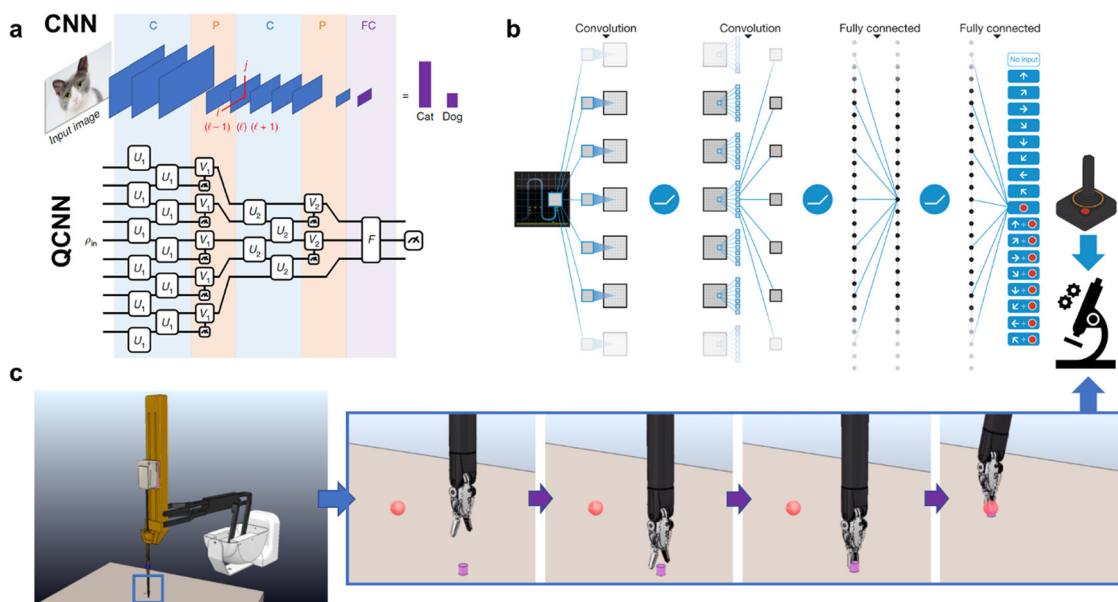
Generally, the main goal is finding rare events deviating from a standard model background (*i.e.* the main theoretical model describing the elemental particles and their interactions). Importantly, most of these works are centralised in the Large Hadron Collider (LHC), which the foremost hub to be inspired by.<sup>583,584</sup> Either by a centralised acquisition and processing in the same LHC, or by acquiring in LHC and processing in collaborating centres, or *vice versa*, hardly ever is the LHC not involved in one way or another. In fact, it conducted the main advances in ML for finding these rare events in data. The huge amount of available data and the ease to accurately simulate it made that mainly supervised models were used since the beginning. These were typically based on both CNN and RNN to distinguish between different types of

particles in traces of jets (*e.g.*, quarks *vs.* gluons) or to directly discriminate actual data from background.<sup>585,586</sup> A particularly interesting example representing this trend came from P. Komiske *et al.*'s work, in the framework of physics-aware models.<sup>585</sup> The authors used a CNN in which the input was a multichannel image and the output the subtle features and patterns (*e.g.* particles) to detect. The novelty lied in that the first channel of the input image represented the image itself, but every additional one represented a different measured physical property. In this way, the authors made sure the model would treat differently two images if obtained under different experimental conditions, consequently making the model aware of the experimental setup employed. The idea introduced here is of paramount importance for ML-based EM and will be developed a few subsections ahead. Also of great importance is the use of generative models in the field. In fact, we could find multiple studies exploiting the goodness of GANs, specially for simulating particle showers, as reviewed above.<sup>587–589</sup> The advances and examples in EM using GANs are not scarce, but as mentioned, they have only just scratched the surface of what is possible. Again, and in a general basis, the EM community should slowly push towards embracing generative models over supervised ones, even if it may seem intimidating. This is why, the imitation of the progress done in the previous jet-simulator GANs studies may serve us to simplify an otherwise titanic task.

**4.2.2.2 Quantum machine learning.** The outstanding level of the ML practitioners in high-energy physics allowed the field to reach the next level of complexity: quantum ML (QML). While the quantum computing researchers strenuously battle to profile the problems and algorithms that can benefit from quantum mechanics, the research on particle physics has already applied some solutions based on this new paradigm.<sup>590</sup> In any case, the end-to-end QML is currently a chimera, although intermediate steps such as algebra, linear differential equations solving, or pattern recognition have been implemented.<sup>591,592</sup> Excitingly, the literature referring to quantum advantage in this field is vast, although we want to specifically highlight the next piece of work given its potential (direct) applicability to EM. S. Chen *et al.* proposed a quantum CNN to classify multiple high-energy physics events.<sup>593</sup> In the model, the convolution operations were performed by a variational quantum circuit, which is a set of quantum states and parameters that can be optimised iteratively and classically. In this case, the network consisted of only two quantum convolutional kernels, but already learned and tested faster than the classical analogue (Fig. 9a).<sup>594</sup> Therefore, we cannot help seeing this exact same quantum kernel learning the patterns from EM images, as the workflow is exactly the same as the multiple times reviewed along this contribution.

Interestingly enough, two of the main hot topics in the current quantum computing/quantum ML research could be of direct concern for EM. These are quantum Fourier transforms and quantum image processing.<sup>595–597</sup> This increasing interest is based on the belief of the eventual supremacy of quantum computing for these applications.<sup>594,598–600</sup> As a result, it is easy to get overexcited with the perspectives QML would promise in





**Fig. 9** Future perspectives of advanced Machine Learning (ML) for Electron Microscopy (EM) data analysis and automation. (a) Quantum Convolutional Neural Networks (QCNN) in high-energy physics already provided quantum advantage *versus* classical CNN even with just two convolution kernels. However, there are no research examples of quantum ML in EM yet.<sup>594</sup> Reprinted by permission from Springer Nature, I. Cong *et al.*, *Nat. Phys.*, 2019, **15**, 1273–1278, Copyright (2019). (b) Schematic of a Reinforcement Learning (RL) CNN designed to autonomously play videogames. The convolutional layers allowed to get information from the videogame frames and to translate that into actions (joystick + buttons) that would maximise the score in a given game. Instead of a joystick, we can think of the microscope control panel in a RL approach that seeks to maximise the image quality.<sup>642</sup> Reprinted by permission from Springer Nature, V. Mnih *et al.*, *Nature*, 2015, **518**, 529–533 Copyright (2015). (c) RL used to train an autonomous surgical robot. The RL trained the robot to take the elements on the table one upon the other as in a surgical intervention. The algorithm would reward putting the objects together and penalise any other action that would not end up in this result.<sup>627</sup> We can imagine a similar robot that takes a lamella or a grid to a holder and afterwards inserts it into the electron microscope. Furthermore, if we concatenate this autonomous holder loader/insertor with the joystick-like approach, we obtain the fully automated microscope!

these two routinary processes in EM. Nevertheless, as reviewed through the entire text, the path classical ML must follow is still huge, and QML should only be thought as a complementary and exploratory tool, by now. For instance, it would make sense to explore the advantages of QML for well-established applications such as DL-based atomic-column finding. Even to just prepare the equivalent algorithms for the highly-anticipated establishment of quantum computers, or for testing them in quantum simulators or tensor networks, just like the quantum computing practitioners do. On the other hand, exploring the new horizons of the ML functionalities in EM, directly stepping through quantum algorithms might be detrimental given the additional implementation barriers.

Quantum algorithms are thought to transform the modelling of physical systems in which quantum physics have a primordial role. As nanostructures are typically ruled by quantum laws, the access to these machines should enhance its simulation fidelity. In the case of EM, as commented, the required level of theory to build large datasets for ML applications is not too strict. However, using quantum circuits to force a physical constrain in our ML models would be amazing. It would allow our models to encode certain complex behaviours that otherwise would be extremely difficult to learn. For instance, an image dataset on classical atomic columns could be immediately converted into an *ab initio* dataset with the following idea: we could train a neural network

on classically simulated atoms but adding a quantum circuit forcing quantum mechanical interactions between them. This idea lies within the science-aware experiment planning, treated in more detail below.

**4.2.3 Earth sciences.** Earth sciences comprise a wide variety of disciplines like meteorology and climate sciences, mineralogy, seismology, and geophysics, among many others. These disciplines have in common a special attention to forecasting and causal analysis. As a result, these domain scientists embraced ML as a logic response for the predictive modelling of different phenomena.<sup>601</sup> Representatively, in climate sciences, unveiling the cause-consequence relations of extreme weather events through data analysis is a major research line.<sup>602–605</sup> Indeed, the literature is full of ML-based examples (*i.e.*, climate informatics) predicting extreme climate events for preventive meteorology.<sup>606–610</sup> For instance, deep CNN are used to detect tropical cyclones, atmospheric rivers and weather fronts, and decision-trees are used for the parametrisation of moist convection in predictive climate modelling.<sup>611,612</sup> The fact these models are fed with images from satellites make the paralleling with electron micrographs direct. Equivalently, in geosciences, ML is employed for predicting land movement, and the magnitude and epicentre of earthquakes and their causes.<sup>613–615</sup> Particularly, the preventive forecast of land tremors based on the seismologic history of a given region of the planet is widely studied by the



community.<sup>616–620</sup> Interestingly, support vector machines could predict the distribution of earthquakes in Indonesia after being trained (*i.e.*, with time, location, magnitude and depth) with 30 years of its seismic history.<sup>621</sup> Similar results were obtained also using support vector machines in the short-term prediction of low-magnitude earthquakes in Cyprus.<sup>622</sup> Support vector machines have a similar behaviour than regular unsupervised clustering, except that they are trainable. Indeed, when seeking for a clustering-like behaviour but labelled data is available (*i.e.*, the label would represent the cluster), the best way to proceed would probably be the training of support vector machines. For example, by grouping seismic data into whether it ended up or not in an earthquake (label), as in the previous examples.

Overall, the image processing and CNN usage of most of these examples only exhibited the first degrees of complexity if compared to EM. This is why, (imaging-based) Earth sciences would leverage the previously reviewed image processing techniques. The trivial example is on crystallography, which is key for geology. Oppositely, as evaluated, Earth sciences excel in forecasting tasks. As a result, EM could take advantage of similar predictive decision-tree algorithmics to work, for instance, in conjunction with CS. Thus, they could fill missing data gaps through predictions, after being trained on pairs of partial-complete datasets. These data gaps could be either time-resolved for an efficient and low-dose *in situ* setup, 3D-correlated to overcome the missing wedges in tomography, or for partial scans in STEM, as happened with CS. Another application of interest would include the prediction of events such as spontaneous crystallisation or phases transitions during *in situ* experiments.

### 4.3 Artificial human-like systems: the path towards automation?

As discussed, the ultimate goal of AI in EM is the total automation of the electron microscope. In other words, we dream of a TEM to autonomously behaving as if it was operated by a human expert. With this major goal in mind, the close examination of technological fields devoted to automating human actions can be highly beneficial. Obviously, the major methodology breakthroughs are linked to the fundamental research on pure computer science and AI. Unfortunately, though, these are occasionally difficult to abstract to practical cases. Nevertheless, there are some fields closer to the application development the strategies of which might be even more useful for the practical purposes to which our community is devoted: robotics and videogames. These disciplines rapidly come to mind when thinking on complex automated behaviours and continuous interactions with human beings, similarly to voice-assistant services. For EM, the main automation challenge is in the reproduction of domain-specific knowledge rather than in the development of complex methodologies. At the end, the microscope automation would just demand the tuning of the lenses, which is translated as modifying a value in a software. In a second stage of complexity, the most exotic automation step would be sample mounting and holder insertion/extraction. Indeed, robotics and videogames present manifold automation routines oriented to multiple processes of comparable or even higher complexity in their mechanics.<sup>623–625</sup> For instance,

ML was used in more critical situations such as the training of surgical robots both to precisely respond to the inputs of surgeons, and to perform key interventions in the absence of human supervisors (Fig. 9c).<sup>626,627</sup> More closely related to materials science, robotics already proved the autonomous ML-guided discovery of materials and nanostructures.<sup>628,629</sup> Therefore, the technology that should unlock the autonomous TEM is already here, “only” requiring the community’s effort for guiding it to the longing goal.

Interestingly, one of the challenges in the nowadays robotics is the better identification and representation of the elements present in the robots environment.<sup>630</sup> Equivalently, we have reviewed many examples of identification of these features in EM micrographs and spectra, mainly by CNN. However, EM could take extra advantage of a trend in robotics called perceptual learning, which aims to optimise the feedback with the environment.<sup>631</sup> Bioinspired, perceptual learning modifies the nature of signals before reaching the traditional learning algorithms to enhance the interpretability. As if electron micrographs were abstracted and encoded (*e.g.*, through simple processes like downsampling, filtering, (*e.g.*, Fourier transforming) before the main processing through the deep convolutional filters of a CNN. Particularly, this idea is becoming key in the development of mobile robots.<sup>632,633</sup> The TEM cannot be considered a mobile robot, although the constantly changing interaction with the environment (*i.e.*, changing magnification and sample position) is comparable and could surely benefit from perceptual pre-processing. Even the holder handling and loading could be directly tackled with the mobile robot perspective!

Another learning paradigm that is being and will be a primary breakthrough for robotics is RL.<sup>489,634</sup> Surprisingly, its applicability to robotics is mainly motivated by its reach and research in videogames. From the well-known Deep Blue that defeated the chess world champion Garry Kasparov, and DeepMind’s AlphaGo that beat the Go world champion Lee Sedol, to recent algorithms capable to beat much more complex game mechanics, the AI in videogames has constantly evolved since its simple origins. It was capable of remarkable milestones even if it was not actually based on AI algorithms: Deep Blue relied on a traditional brute-force decision tree while AlphaGo was based on Monte Carlo tree search. In summary, these algorithms are based on the so-called behaviour trees, an evolution of predefined states reacting to certain stimuli, following a heuristic logic. It was only recently when videogames incorporated AI to generate human-behaving game engines, but also to self-challenge these same games.<sup>635</sup> RL, together with evolutionary algorithms and automated ML burst into the field to answer the need of adaptability.<sup>636–639</sup> Meaning that a supervised model will perform great to a given data but cannot be adapted to new data unless it is trained with it. These new paradigms act as if they were continuously trained with the new data they may end up facing. The main idea behind these new learning paradigms is the iterative maximisation of a score or fitness metric that encodes whether the model performed well or not in a given task. Thanks to this, powerful RL algorithms such as deep Q-Network or Go-Explore surpassed the human performance in multiple videogames (Fig. 9b).<sup>640–642</sup> Interestingly, the mechanics of some of



these games implied hundreds of actions that required optimisation depending on the in-game situation. Astonishingly, some learned action trees (*i.e.*, the decisions of the RL algorithm) could go beyond the preestablished rules of the game in favour of the score maximisation.<sup>643</sup> Yes, the AI learned to cheat in these games! In terms of implementation, importantly, the main companies developing these algorithms, such as OpenAI or DeepMind, provide RL solutions for free to academia that constitute optimal starting points for introducing newcomers to these new learning paradigms.<sup>644–646</sup>

Going back to the microscope automation, the correlation with the proposed research is direct, and the cross-fertilisation, welcome. As indicated, a robotic electron microscope would autonomously change the power of the electromagnetic lenses to improve the image quality. In this case, the image quality would represent the score whilst the modifiable lenses are the interactable parameters. Therefore, the problem is reduced to the optimal choice of the score metric based on the data to acquire. Defocus and higher-order aberrations, artifacts, and the different regions of interest in our nanodevices should be encoded in this metric, assessing the quality of the data and the complete scanning of the nanostructure. More precisely, this problem would lie in the sparse-reward framework of RL, in which a positive reward might depend on multiple consecutive and correct actions. Importantly, the identification of the features defining the score metric was mostly automated by the reviewed examples.<sup>35–38,40–44,473</sup> Then, the goal would be to reduce this sparsity or make it less meaningful. One option could be linking each tuneable parameter with a score modification, which would imply a hard encoding of the score. In addition, this score or metric could be further guided as well by recorded microscopy sessions capturing the variation of the tuneable parameters and the resulting transient image quality. Alternatively, and mimicking the research on videogames, multiagent training could enhance the creativity of the algorithms in modifying the interactable parameters towards a top score.<sup>642,643</sup> Thus, training competing agents on the same problem to force unexpected behaviour trees. This could be translated into many microscopy sub-routines or entire microscopes parallelly competing with each other to maximise the sparse score based on the image quality. Excitingly, this could potentially mean just leaving the microscopes being trained alone (*i.e.*, trial and error to maximise the score) for a week to retrieve a fully operative autonomous entity afterwards. Even more excitingly, this could lead to innovative ways to operate the microscopes that we, as trained humans, could have never thought before, in the same way a reinforced AI can break the game designers' rules.

#### 4.4 Other fields of research

Beyond the discussed learning paradigms like RL, automated ML, or evolutionary algorithms, complementary constraints can also add extra value to the more traditional supervised and unsupervised approaches. We have briefly stated through this review the importance of adding knowledge constraints to ML algorithms. Interestingly, this can simplify our model in terms of necessary training volume and architecture complexity.

Moreover, if adequately planned, the response of the models against the constrained physical parameters should be more general and easier to achieve and interpret.

The first way to explore physics constraints and also the typical way to introduce them in our models is by guiding the algorithms as steps with a physically logical sequence.<sup>647</sup> This is the workflow of the 99% of works in any scientific field and is just processing the data differently based on the science ruling the phenomena. Indeed, the concept we want to communicate is the natural inclusion of this logic in end-to-end ML models that overwrite the manual steps. A great starting point is to use models the architecture of which explicitly carry a physical constraint. In this case, approaches like the previously reviewed rVAEs are capable of extracting some latent variables with physical constraints like rotations or translations as output.<sup>84,87</sup> Furthermore, in the formal science-guided approach, we *a priori* set a physical constraint forcing the ML model to have this predefined condition or consideration as part of its nature.<sup>648,649</sup> A straightforward implementation can just be the addition of accessory channels to EM images, each of which accounts for an experimental parameter of the acquisition. For instance, adding the defocus in a focal series for its automated reconstruction, or adding a channel per independent aberration in a digital post-acquisition aberration corrector. A clear example already reviewed doing this was the work of L. Roest *et al.* for modelling the ZLP in different experimental conditions.<sup>296</sup> Another option to physically constrain models is the modification of the architecture of *a priori* unphysical models to capture these restrictions. Although it is not strictly EM, the following inspirational example in the framework of X-ray coherent diffraction imaging represents this idea. Moreover, it would be equivalent to EM as it provides a 3D reciprocal reconstruction similar to electron diffraction tomography. In this way, H. Chan *et al.* built a 3D autoencoder with a single encoder-double decoder architecture trained to invert 3D X-ray diffraction patterns into real space information of nanostructures.<sup>650</sup> The innovation lied in the multiple-decoder architecture that allowed to split the training and the output in different physically distinctive information: in the present case, the predicted shape of the nanostructure (retrieved amplitude) and its strain through (retrieved phase). The authors named this architecture AutoPhaseNN and proved its inverse reconstruction to be about one hundred times faster than other phase retrieval methods.<sup>651</sup> This work is an equivalent approach to the reported PtychoNN for EM ptychography reconstructions.<sup>121</sup> Nonetheless, the main inherent drawback of doubling the outputs is the consequent doubling of the required labels for training. Therefore, this would almost deny the possibility to train this kind of models with experimental data. Oppositely, when using synthetic simulated data, the obtention of extra labels will not cost additional computing resources, making it the preferred choice (*i.e.*, in simulations, we get simultaneously the phase and the amplitude, both useable as double labels). In conclusion, this application further highlighted the potential of physics-aware modelling to enhance the research in more general reverse engineering EM scenarios.<sup>652–655</sup> Unfortunately, similar instances in EM are not yet common, certainly displaying a knowledge gap yelling to be filled.





Quite related, the physics-aware architecture design might be intuitively represented by the recent advances in graph neural networks.<sup>656</sup> As mentioned, the properties of EM datasets should allow a direct transformation of their formats into graph representations. The easiest example would apply for an image in which each pixel represents a node and connects with as many edges as neighbouring pixels. There is an absence of EM bibliography referring to the potential benefits of graph networks for image processing, although more general computer vision applications have already benefited from them.<sup>657,658</sup> Indeed, multiple physically constraining strategies can be followed at once to improve the generalisation capabilities of the final model. Indeed, a fatal error would be to limit the thinkable possibilities of the reviewed tools to just the reviewed cases and the resembling. Interestingly, general digital imaging benefited from combining a 3D CNN with graph neural networks and the distance channel (*i.e.* physical constrain) of RGB-D data to automatically segment images.<sup>659</sup> The addition of the D channel (in-depth distance) allowed to, by graph representations, encode and refine geometric information otherwise impossible to extract only with intensity-based channels. Conveniently, this simple constraining of digital images consolidated the previous discussion on the benefits that even a simple physics guiding may have.

Nonetheless, when graph-like systems were allowed to evolve in time under a certain physical constraint, graph networks showed the most outstanding and promising results. For example, when they were used to simulate dynamical systems for providing trustworthy digital twins of complex physical behaviours like mass-springs, rigid bodies (*e.g.*, to be applied in a videogames physics engine, closing the previous sections loop), molecules, or to encode finite element simulations, among others.<sup>485,486,488</sup> Again, the previous examples would better fit into pure AI research, but the versatility these graph neural networks have shown are worth the exploration. As briefly pointed through the document, the properties of graph networks could be applied to EM, for instance, to follow the evolution of features changing along an *in situ* stimuli. Either by the pixelwise evolution of node-per-pixel graphs, or by the identification of features and its posterior encoding into connected nodes. We would like to warn the reader, not to forget that complementarily, this already scientific and technical encoding could be further assisted by adding extra information channels to the micrographs with the mentioned stimuli: time frame of a sequence, voltage, gas pressure, beam intensity, the discussed distance-to-camera, *etc.*<sup>659</sup>

To conclude this section, we want to briefly go through a vast and distant field of knowledge specially experienced in the parallel optimisation of huge multivariate systems: marketing and finances. Both marketing and finances automated most of their routinary tasks by using ML.<sup>660–662</sup> On one hand, marketing seeks to turn into a variable every action a customer may do, first, before deciding to buy a product, and then to actually buy it. As a result, monitoring and statistically linking these variables for all the potential customers would represent a titanic task in which ML has already provided insight.<sup>663,664</sup> On the other hand, the automation of small stock transactions avoiding

cognitive biases, or the creation of optimised portfolios given an investor's profile, count as ML-based daily-life operations.<sup>665–667</sup> The common pattern in both fields lies behind the assignation and optimisation of the variables, typically numerous and with intricate data structures. For EM, this expertise might help in experiment planning and decision-making refinement in autonomous EM, through a set of predefined goals and sample features constituting the variables space. Additionally, the optimisation of financial and trading problems has undergone through meaningful improvements with quantum computing, and more precisely with QML.<sup>668–670</sup> Therefore, as introduced by the research in high-energy physics leading to the consequent possibilities of QML in EM, quantum finances strike to reiterate the likely future of EM with QML.

## 5. Conclusions and final remarks

Through this document, we have reviewed in detail the advances that ML has introduced to the broad field of EM. By unavoidably sliding to the domains of materials science, the main electron-based imaging and spectroscopy techniques have revealed important scenarios in which ML is shown to be essential to decipher new physical phenomena, to model nanostructures or for advanced micrograph and multidimensional data processing, among many others. From traditional parallel-beam TEM and STEM imaging to the possibilities of 4D STEM, and from spectrum profiles to fully 3D compositional maps, the variability of unsupervised, supervised, semi-supervised, generative and RL, or even CS, have extensively showed their goodness. Nevertheless, we have also shown and discussed the current ML challenges, still open due to the early stage of the ML journey into the EM community.

This early stage and the recent motivating discoveries will likely turn into an avalanche of (electron) microscopists wanting to become ML practitioners. Consequently, we have tried to provide an easy step-by-step guide for microscopists and materials scientists to start with ML despite their initial level. Our scope was not the review of the algorithms and algebra behind ML, as there are endless resources covering this, but to present a sorted set of tools that may make the (new) practitioners' life much easier. At least in the first stages, applications, or prototypes. Relatedly, the guide aimed to schematically educate about the possibilities of ML in EM applied to materials science. Ideally, its application should be accompanied by the deepest possible understanding of the mathematical models behind to avoid falling into the comfortable but dangerous void of the black boxes.

Finally, the exploration of the ML literature around other scientific fields, revealed an enormous source of refined methodologies and successful implementations of AI into science. From neighbouring microscopies to high-energy physics and astronomy, and even from apparently unrelated fields such as videogames or finances. From all of them we have been able to extract valuable insight to draw the future in which the EM/materials science points to. Interestingly enough, while surfing



this literature some of the unanswered challenges presented for EM started receiving a preliminary treatment. As we frequently wrote, the slight adaptation and fine tuning of certain reviewed methodologies would instantly mean solving or improving a lack in EM. It could be a data-format transformation, or just a direct exchange between physical properties, but rarely a logistically prohibitive process. Moreover, the reviewed technical and scientific fields outlined the learning paradigms that must rule the progress of the next decade, with RL and generative modelling being the most promising ones. In addition, special care and attention must be paid to QML as a future insurance, but specially to physically-aware AI as a present guarantee. In conclusion, we wanted to foster the habit of browsing through other fields to seek for new ideas to implement in the readers' own community. The idea of intercommunicating scientific fields is rich and global and adds value to one of the most beautiful aspects of ML being the amazing community devoted to open science and knowledge transfer.

## Abbreviations

|       |                                                  |
|-------|--------------------------------------------------|
| AFM   | Atomic force microscopy                          |
| AI    | Artificial intelligence                          |
| CL    | Cathodoluminescence                              |
| CBED  | Convergent-beam electron diffraction             |
| CNN   | Convolutional neural network                     |
| CS    | Compressive sensing                              |
| DFT   | Density functional theory                        |
| DL    | Deep learning                                    |
| DPC   | Differential phase contrast                      |
| EDX   | Energy dispersive X-ray spectroscopy             |
| EELS  | Electron energy loss spectroscopy                |
| EFTEM | Energy-filtered transmission electron microscopy |
| ELNES | Energy loss near edge structure                  |
| EM    | Electron microscopy                              |
| ES    | Electron spectroscopy                            |
| ET    | Electron tomography                              |
| FCNN  | Fully convolutional neural network               |
| FFT   | Fast Fourier transform                           |
| FSL   | Few-shot learning                                |
| GAN   | Generative adversarial network                   |
| GMM   | Gaussian mixture modelling                       |
| GP    | Gaussian processing                              |
| HAADF | High-angle annular dark-field                    |
| HRTEM | High-resolution transmission electron microscopy |
| ICA   | Independent component analysis                   |
| LHC   | Large hadron collider                            |
| ML    | Machine learning                                 |
| MLP   | Multilayer perceptron                            |
| MRI   | Magnetic resonance imaging                       |
| NMF   | Non-negative matrix factorisation                |
| PCA   | Principal component analysis                     |
| QML   | Quantum machine learning                         |
| RL    | Reinforcement learning                           |

|       |                                                 |
|-------|-------------------------------------------------|
| RNN   | Recurrent neural network                        |
| rVAEs | Rotationally invariant Variational AutoEncoders |
| SEM   | Scanning electron microscopy                    |
| SI    | Spectrum image                                  |
| SNR   | Signal-to-noise ratio                           |
| SPM   | Scanning probe microscopies                     |
| ST    | Spectral tomography                             |
| STEM  | Scanning transmission electron microscopy       |
| STM   | Scanning tunnelling microscopy                  |
| SVD   | Singular value decomposition                    |
| TEM   | Transmission electron microscopy                |
| VAEs  | Variational autoencoders                        |
| VCA   | Vertex component analysis                       |
| XRD   | X-ray diffraction                               |
| ZLP   | Zero-loss peak                                  |

## Conflicts of interest

There are no conflicts to declare.

## Acknowledgements

The authors acknowledge funding from Generalitat de Catalunya 2017 SGR 327. ICN2 is supported by the Severo Ochoa programme from the Spanish Ministry of Economy (MINECO) (grant no. SEV-2017-0706) and is funded by the CERCA Programme/Generalitat de Catalunya. The authors thank support from the project NANOGEN (PID2020-116093RB-C43), funded by MCIN/AEI/10.13039/501100011033/and by "ERDF A way of making Europe", by the "European Union". Part of the present work has been performed within the framework of the Universitat Autònoma de Barcelona Materials Science PhD programme. We acknowledge support from CSIC Interdisciplinary Thematic Platform (PTI+) on Quantum Technologies (PT-QTEP+). M. B. acknowledges funding from SUR Generalitat de Catalunya and the EU Social Fund; project ref. 2020 FI 00103. This study was supported by MCIN with the funding form European Union NextGenerationEU (PRTR-C17-I1) and Generalitat de Catalunya. This study was supported by EU HORIZON INFRA TECH 2022 project IMPRESS (Ref.: 101094299).

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